

TEST REPORT

CERTIFICATE OF CONFORMITY

Standards: EN 55032:2015 +A11:2020, Class A

CISPR 32:2015 +Cor 1:2016, Class A AS/NZS CISPR 32:2015, Class A

EN 61000-3-2:2014 EN 61000-3-3:2013

EN 55035:2017 +A11:2020

Report No.: CEBDBO-WTW-P21115053

Model No.: EIC-1000

marketing purposes)

Received Date: 2021/11/26

Test Date: 2021/12/1 ~ 2021/12/10

Issued Date: 2022/1/4

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Issued By: Bureau Veritas Consumer Products Services (H.K.) Ltd., Taoyuan Branch Lin Kou

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Approved by: _______, Date:

Date: 2022/1/4

Jim Hsiang / Associate Technical Manager

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Prepared by: Vivian Chen / Senior Specialist

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Report No.: CEBDBO-WTW-P21115053 Page No. 1 / 77 Report Format Version: 7.1.0



Table of Contents

Rel	lease Control Record	4
1	Certification	5
2	Summary of Test Results	6
2.		
2.	,	
2.	.3 Supplementary Information	10
3	General Information	11
3.	.1 Description of EUT	11
3.		
3.		
3.		
3.	.5 Test Program Used and Operation Descriptions	12
3.	.6 Connection Diagram of EUT and Peripheral Devices	13
3.	.7 Configuration of Peripheral Devices and Cable Connections	15
4	Test Instruments	16
4.	.1 Conducted Emissions from Power Ports	16
4.		
4.		18
4.	·	
4.	.5 Harmonics Current Measurement	20
4.	.6 Voltage Fluctuations and Flicker Measurement	20
4.	5 \	
4.		
4.	\	
	.10 Surge	
	.11 Radio Frequency Common Mode (CS)	
	.12 Power Frequency Magnetic Field (PFMF)	
	.13 Voltage Dips and Interruptions (DIP)	
5	Limits of Test Items	
5.		
5.		
5.	· · · · · · · · · · · · · · · · · · ·	
5.		
5.		
5.	· · · · · · · · · · · · · · · · · · ·	
5.	.7 General immunity requirements	29
6	Test Arrangements	31
6.		
6.		
6.	·	
6.		
6.		
6.	· · · · · · · · · · · · · · · · · · ·	
6.		
6. 6.	1 7 0 1	
	.9 Fast Transients Common Mode (EFT)	
	.11 Radio Frequency Common Mode (CS)	42 AA
	.12 Power Frequency Magnetic Field (PFMF)	
	.13 Voltage Dips and Interruptions (DIP)	
	Test Results	
7	1691 V69nir9	48



7.1	Conducted emissions from Power Ports	48
7.2	Conducted Emissions from Wired Network Ports	52
7.3	Radiated Emissions up to 1 GHz	53
7.4	Radiated Emissions above 1 GHz	55
7.5	Harmonic Current Measurement	
7.6	Voltage Fluctuations and Flicker Measurement	57
7.7	Electrostatic Discharge (ESD)	58
7.8	Radio Frequency Electromagnetic Field (RS)	62
7.9	Fast Transients Common Mode (EFT)	62
7.10	Surge	
7.11	Radio Frequency Common Mode (CS)	63
7.12	Power Frequency Magnetic Field (PFMF)	
7.13	Voltage Dips and Interruptions (DIP)	65
8 Pic	ctures of Test Arrangements	66
8.1	Conducted Emissions from Power Ports	66
8.1 8.2	Conducted Emissions from Power Ports	
-		67
8.2	Conducted Emissions from Wired Network Ports	67 68
8.2 8.3	Conducted Emissions from Wired Network Ports	67 68 69
8.2 8.3 8.4	Conducted Emissions from Wired Network Ports Radiated Emissions up to 1 GHz Radiated Emissions above 1 GHz Harmonic Current Measurement Voltage Fluctuations and Flicker Measurement	
8.2 8.3 8.4 8.5	Conducted Emissions from Wired Network Ports Radiated Emissions up to 1 GHz Radiated Emissions above 1 GHz Harmonic Current Measurement Voltage Fluctuations and Flicker Measurement Electrostatic Discharge (ESD)	
8.2 8.3 8.4 8.5 8.6	Conducted Emissions from Wired Network Ports Radiated Emissions up to 1 GHz Radiated Emissions above 1 GHz Harmonic Current Measurement Voltage Fluctuations and Flicker Measurement Electrostatic Discharge (ESD) Radio Frequency Electromagnetic Field (RS)	
8.2 8.3 8.4 8.5 8.6 8.7	Conducted Emissions from Wired Network Ports Radiated Emissions up to 1 GHz Radiated Emissions above 1 GHz Harmonic Current Measurement Voltage Fluctuations and Flicker Measurement Electrostatic Discharge (ESD)	
8.2 8.3 8.4 8.5 8.6 8.7 8.8	Conducted Emissions from Wired Network Ports Radiated Emissions up to 1 GHz Radiated Emissions above 1 GHz Harmonic Current Measurement Voltage Fluctuations and Flicker Measurement Electrostatic Discharge (ESD) Radio Frequency Electromagnetic Field (RS) Fast Transients Common Mode (EFT) Surge	
8.2 8.3 8.4 8.5 8.6 8.7 8.8 8.9 8.10 8.11	Conducted Emissions from Wired Network Ports Radiated Emissions up to 1 GHz Radiated Emissions above 1 GHz Harmonic Current Measurement Voltage Fluctuations and Flicker Measurement Electrostatic Discharge (ESD) Radio Frequency Electromagnetic Field (RS) Fast Transients Common Mode (EFT) Surge Radio Frequency Common Mode (CS)	
8.2 8.3 8.4 8.5 8.6 8.7 8.8 8.9 8.10	Conducted Emissions from Wired Network Ports Radiated Emissions up to 1 GHz Radiated Emissions above 1 GHz Harmonic Current Measurement Voltage Fluctuations and Flicker Measurement Electrostatic Discharge (ESD) Radio Frequency Electromagnetic Field (RS) Fast Transients Common Mode (EFT) Surge Radio Frequency Common Mode (CS) Power-frequency magnetic fields (PFMF)	
8.2 8.3 8.4 8.5 8.6 8.7 8.8 8.9 8.10 8.11	Conducted Emissions from Wired Network Ports Radiated Emissions up to 1 GHz Radiated Emissions above 1 GHz Harmonic Current Measurement Voltage Fluctuations and Flicker Measurement Electrostatic Discharge (ESD) Radio Frequency Electromagnetic Field (RS) Fast Transients Common Mode (EFT) Surge Radio Frequency Common Mode (CS)	



Release Control Record

Issue No.	Description	Date Issued
CEBDBO-WTW-P21115053	Original release.	2022/1/4



1 Certification

Product: Arm-Based Edge Computing System

Brand: Vecow

Test Model: EIC-1000

purposes)

Sample Status: Engineering sample

Applicant: Vecow Co., Ltd.

Test Date: 2021/12/1 ~ 2021/12/10

Standards: EN 55032:2015 +A11:2020, Class A

CISPR 32:2015 +Cor 1:2016, Class A AS/NZS CISPR 32:2015, Class A

EN 61000-3-2:2014 EN 61000-3-3:2013

EN 55035:2017 +A11:2020

Measurement EN 61000-4-2:2009 / IEC 61000-4-2:2008 ED. 2.0

procedure: EN 61000-4-3:2006 +A1:2008 +A2:2010 / IEC 61000-4-3:2010 ED. 3.2

EN 61000-4-4:2012 / IEC 61000-4-4:2012 ED. 3.0

EN 61000-4-5:2014 +A1:2017 / IEC 61000-4-5:2017 ED. 3.1 EN 61000-4-6:2014+AC:2015 / IEC 61000-4-6:2013 ED. 4.0

EN 61000-4-8:2010 / IEC 61000-4-8:2009 ED. 2.0

EN 61000-4-11:2004 +A1: 2017 / IEC 61000-4-11:2017 ED. 2.1

The above equipment has been tested by **Bureau Veritas Consumer Products Services (H.K.) Ltd., Taoyuan Branch**, and found compliance with the requirement of the above standards. The test record, data evaluation & Equipment Under Test (EUT) configurations represented herein are true and accurate accounts of the measurements of the sample's EMC characteristics under the conditions specified in this report.



2 Summary of Test Results

The test items that the EUT needs to perform according to its interfaces and functions evaluation are as follows:

Standard	Test Item	Result	Remarks
EN 55032	Conducted Emissions from Power Ports	Pass	Minimum passing Class A margin is -28.25 dB at 0.64858 MHz.
EN 55032	Conducted Emissions from Wired Network Ports	Pass	Minimum passing Class A margin is -0.20 dB at 0.49799 MHz.
	Radiated Emissions up to 1 GHz	Pass	Minimum passing Class A margin is -2.26 dB at 125.03 MHz
EN 55032	Radiated Emissions above 1 GHz	Pass	Minimum passing Class A margin is -13.06 dB at 5940.18 MHz.
EN 61000-3-2	Harmonic Current Measurement	Pass	The power consumption of EUT is less than 75W and no limits apply
EN 61000-3-3	Voltage Fluctuations and Flicker Measurement	Pass	Meets the requirements.
IEC 61000-4-2	Electrostatic Discharges (ESD)	Pass	For EN 55035 Performance Criteria A
IEC 61000-4-3	Radio Frequency Electromagnetic Field (RS)	Pass	For EN 55035 Performance Criteria A
IEC 61000-4-4	Fast Transients Common Mode (EFT)	Pass	For EN 55035 Performance Criteria A
IEC 61000-4-5	Surges	Pass	For EN 55035 Performance Criteria A
IEC 61000-4-6	Radio Frequency Common Mode (CS)	Pass	For EN 55035 Performance Criteria A
IEC 61000-4-8	Power Frequency Magnetic Field (PFMF)	Pass	For EN 55035 Performance Criteria A
IEC 61000-4-11	Voltage Dips and Interruptions (DIP)	Pass	For EN 55035 Voltage Dips: < 5 % residual, 0.5 cycle, Performance Criteria A 70% residual, 25 cycles Performance Criteria C Voltage Interruptions: < 5 % residual, 250 cycles Performance Criteria C

Note: Determining compliance based on the results of the compliance measurement, not taking into account measurement instrumentation uncertainty.

Report No.: CEBDBO-WTW-P21115053 Page No. 6 / 77 Report Format Version: 7.1.0



2.1 Performance Criteria

General Performance Criteria

These criterions shall be used during the testing of primary functions where no specified in the normative annexes of EN 55035 is applicable.

Performance criterion A

The equipment shall continue to operate as intended without operator intervention. No degradation of performance, loss of function or change of operating state is allowed below a performance level specified by the manufacturer when the equipment is used as intended. The performance level may be replaced by a permissible loss of performance. If the minimum performance level or the permissible performance loss is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and by what the user may reasonably expect from the equipment if used as intended.

Performance criterion B

During the application of the disturbance, degradation of performance is allowed. However, no unintended change of actual operating state or stored data is allowed to persist after the test.

After the test, the equipment shall continue to operate as intended without operator intervention; no degradation of performance or loss of function is allowed, below a performance level specified by the manufacturer, when the equipment is used as intended. The performance level may be replaced by a permissible loss of performance.

If the minimum performance level (or the permissible performance loss), or recovery time, is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and by what the user may reasonably expect from the equipment if used as intended.

Performance criterion C

Loss of function is allowed, provided the function is self-recoverable, or can be restored by the operation of the controls by the user in accordance with the manufacturer's instructions. A reboot or re-start operation is allowed.

Information stored in non-volatile memory, or protected by a battery backup, shall not be lost.

Report No.: CEBDBO-WTW-P21115053 Page No. 7 / 77 Report Format Version: 7.1.0



Product Specific Performance criteria for network functions

Equipment that provides these functions transmits and receives data through ports such as an analogue/digital data port. The networking functions are just like network switching and routing; data transmission; supervisory...etc.

The particular performance criteria which are specified in the normative annexes of CISPR 35/EN 55035 take precedence over the corresponding parts of the general performance criteria.

Performance criterion A

Where relevant, during the application of the test the network function shall, as a minimum, operate ensuring that:

- established connections shall be maintained throughout the application of the test;
- no change of operational state or corruption of stored data occurs;
- no increase in error rate above the figure defined by the manufacturer occurs. The manufacturer should select the most appropriate performance measurement criteria for the product or system, for example bit error rate, block error rate;
- no request for retry above the figure defined by the manufacturer;
- the data transmission rate does not reduce below the figure defined by the manufacturer;
- no protocol failure occurs;
- other verifications are described in F.3.3.1 of CISPR 35/EN 55035.

Performance criterion B

Established connections shall be maintained throughout the test, or shall self-recover in a way and timescale that is imperceptible to the user.

The error rate, request for retry and data transmission rates may be degraded during the application of the test. Degradation of the performance as described in criterion A is permitted, provided that the normal operation of the EUT is self-recoverable to the condition established prior to the application of the test.

Where required, as defined in Clause 5 of CISPR 35/EN 55035, the acceptable operation of the function shall be verified at the completion of the test as described in Table H.1 of CISPR 35/EN 55035, by confirming the following:

- the EUT's ability to establish a connection.
- the EUT's ability to clear a connection.

During surge testing disconnection is allowed on the analogue/digital data port being tested.

If the EUT is a supervisory equipment, it shall not impact the normal operation of the network being monitored. In addition, any supervisory functions impacted during the period of the test shall return to the state prior to the test. Elements to consider include: alarms, signalling lamps, printer output, network traffic rates, network monitoring.

Performance criterion C

Degradation of performance as described in criteria A and B is permitted provided that the normal operation of the EUT is self-recoverable to the condition immediately before the application of the test, or can be restored after the test by the operator.

Product Specific Performance Criteria for xDSL

The particular performance criteria which are specified in the normative annexes of CISPR 35/ EN 55035 take precedence over the corresponding parts of the general performance criteria.

Performance criterion A

Applicable for the test requirement defined in table clause 2.1 of EN 55035

During the swept frequency test the established connection shall be maintained throughout the testing and the information transferred without any additional reproducible errors or loss of synchronisation. If a degradation in performance is observed and the system is adaptive, for example has the capability to automatically retrain in the presence of an interfering signal, then for conducted immunity tests only, the following procedure shall be followed:

- a) For each range of interfering frequencies in which degradation in performance is observed, three frequencies (beginning, middle and end) shall be identified.
- b) At each of the frequencies identified in step a), the interfering signal shall be turned on and the system is allowed to retrain.
- c) If the system is able to retrain and then functions correctly for a dwell time of at least 60 seconds without any additional reproducible errors or loss of synchronisation, then the performance level of the system is considered acceptable.
- d) The frequencies identified in step a) and the data rates achieved in step b) shall be recorded in the test report.

Applicable for the test requirement defined in table clause 2.2 of EN 55035

It is important that the modems are able to train in the presence of repetitive impulsive noise and minimize disruption to

Report No.: CEBDBO-WTW-P21115053 Page No. 8 / 77 Report Format Version: 7.1.0



the end-user where a repetitive impulsive noise source starts after the link has synchronized. Therefore the following procedure and performance criteria shall apply.

The manufacturer shall select the class of impulsive noise protection (INP) to be used for the immunity test and should state this information in the technical documentation and in the test report. The maximum delay shall be set to 8 ms.

In the absence of impulsive noise: The modem shall operate without retraining at its target noise margin with a bit rate value depending on the line attenuation and the stationary noise being present on the line. (The actual value will be between the minimum and maximum bit rate values programmed in the port).

The impulsive noise source shall then be applied at the required test level.

With the impulsive noise applied: The modem shall operate without retraining and without SES at the bit rate established prior to the application of the impulsive noise. No extra CRC errors shall occur due to the impulsive noise. After the test, the noise margin value shall return to the target noise margin.

Performance criterion B

Applicable for the test requirement defined in table clause 2.3 of EN 55035

Modems shall withstand the occurrence of isolated impulsive noise events. The performance criteria defined in below Table shall be applied.

Impulse duration (ms)	Performance criteria
0.24	The application of the impulse shall not cause the xDSL link to lose synchronisation. No CRC errors are permitted.
10	The application of the 5 impulses shall result in less than 75 CRC errors and shall not cause the link to lose synchronisation.
300	The application of the impulse shall not cause the xDSL link to lose synchronisation.

Applicable for the test requirements defined in table clauses 2.5 and 4.5 of EN 55035

For application of this test to the xDSL port, a repetition rate of 100 kHz (burst length 0.75 ms) shall be used.

Degradation of the performance as described in criterion A is permitted in that errors are acceptable during the application of the test. However the application of the test shall not cause the system to lose the established connection or re-train. At the cessation of the test the system shall operate in the condition established prior to the application of the test without user intervention.

After the application of the EFT/B tests to the xDSL or AC mains port, the CRC error count shall not have increased by more than 600 when compared to the count prior to the application of the test.

Performance criterion C

Degradation of the performance as described in criteria A and B is permitted provided that the normal operation of the EUT is self-recoverable to the condition established prior to application of the test or can be restored after the test by the operator.

Report No.: CEBDBO-WTW-P21115053 Page No. 9 / 77 Report Format Version: 7.1.0



2.2 Measurement Uncertainty

Where relevant, the following measurement uncertainty levels have been estimated for tests performed on the EUT as specified in CISPR 16-4-2:

Measurement	Expanded Uncertainty (k=2) (±)	Maximum allowable uncertainty (±)	
Conducted Emissions from Power Ports	3.00 dB	3.4 dB (<i>U</i> cispr)	
Conducted Emissions from Wired Network Ports	3.94 dB	5.0 dB (<i>U</i> cispr)	
Radiated Emissions up to 1 GHz	4.30 dB	6.3 dB (<i>U</i> _{cispr})	
Radiated Emissions above 1 GHz	4.48 dB	5.2 dB (<i>U</i> cispr)	

The other instruments specified are routine verified to remain within the calibrated levels, no measurement uncertainty is required to be calculated.

2.3 Supplementary Information

There is not any deviation from the test standards for the test method, and no modifications required for compliance.

Report No.: CEBDBO-WTW-P21115053 Page No. 10 / 77 Report Format Version: 7.1.0



3 General Information

3.1 Description of EUT

Product Arm-Based Edge Computing System		
Brand	Vecow	
Test Model	EIC-1000	
Corios Madal	EIC-1000 Series, EIC-1XXXXXXXXXXXXXXXXXXXXXXXXXXXXXXXXXXXX	
Series Model	marketing purposes)	
Model Difference	For marketing purpose.	
Sample Status	Engineering sample	
Operating Software	Debian 9.0	
Power Supply Rating	DC from Adapter	
Accessory Device	N/A	
Data Cable Supplied	N/A	

Note:

The EUT uses following adapter.

Brand FSP	
Model	FSP120-AABN2
Input Power	100-240Vac, 1.8A, 50-60Hz
Output Power	24Vdc, 5.0A, 120W
Power Line	DC cable (1.5m) with one ferrite core.

3.2 Primary Clock Frequencies of Internal Source

The highest frequency generated or used within the EUT or on which the EUT operates or tunes is 2GHz, provided by Vecow Co., Ltd., for detailed internal source, please refer to the manufacturer's specifications.

3.3 Features of EUT

- 1. The tests reported herein were performed according to the method specified by Vecow Co., Ltd., for detailed feature description, please refer to the manufacturer's specifications or user's manual.
- 2. The EUT configured with the following key components:

Components	Brand	Model Specification		Serial code
CPU	Rockchip	Dual Core-A72	2.0GHz	-
CPU	Rockchip	Quad Core-A53	1.5GHz	-
Power Module	Vecow	WPM-140	-	-
Micro SD Card INNODISK MicroSD 3TE4 256GB ET FW:T0914,1CH,WD BICS4				DESDM-B56S06GE1SL

Report No.: CEBDBO-WTW-P21115053 Page No. 11 / 77 Report Format Version: 7.1.0



3.4 Operating Modes of EUT and Determination of Worst Case Operating Mode

- 1. The EUT was pre-tested under operating and standby condition and the worst emission level was found under **operating condition**.
- 2. The EUT consumed power from AC adapter, which designed with AC power supply of 100-240Vac, 50-60Hz. For radiated emission evaluation, 230Vac/ 50Hz & 110Vac/ 60Hz had been covered during the pre-test. The worst radiated emission data was found at **230Vac/ 50Hz** and recorded in the applied test report.
- 3. Test modes are presented in the report as below.

Mode	Test Condition	Input Power					
	Conducted emission test						
1	Full System	230Vac/ 50Hz & 110Vac/ 60Hz					
	Conducted Emissions from Wired network ports test						
1	Full System – LAN port (Speed: 1Gbps) 230Vac/ 50Hz						
	The idle mode of conducted emission test at telecom port was pre-tested based on the worst case of link mode. Due to emissions of idle mode being very low compared to link mode, only the link mode data were presented in the test report.						
	Radiated emission test						
1	Full System	230Vac/ 50Hz					
	Harmonics, Flicker, Immunity tests						
1	Full System	230Vac/ 50Hz					

3.5 Test Program Used and Operation Descriptions

Emission tests (Harmonics & Flicker excluded):

- a. Turned on the power of all equipment.
- b. EUT ran a test program to enable all functions.
- c. EUT read and wrote messages from/to HDD and micro SD card.
- d. EUT sent and received messages to/from Notebook PC/ Desktop PC (kept in a remote area) via an STP LAN cables (10m).
- e. EUT sent "color bars with moving element" messages to LCD Monitor. Then it displayed "color bars with moving element" messages on its screen.
- f. EUT sent "1kHz audio" signal to earphone.
- g. Steps c-f were repeated.

Harmonics, Flicker, Immunity tests:

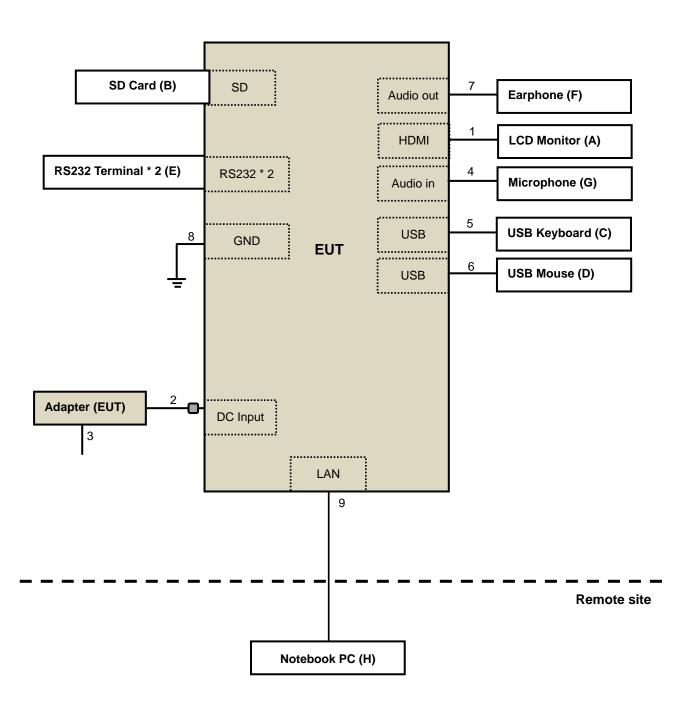
- a. Turned on the power of all equipment.
- b. EUT ran a test program to enable all functions.
- c. EUT read and wrote messages from/to HDD and SD card.
- d. EUT sent and received messages to/from Notebook PC/ Desktop PC (kept in a remote area) via an STP LAN cables (10m).
- e. EUT sent "color bars" messages to LCD Monitor. Then it displayed "color bars" messages on its screen.
- f. EUT sent audio signal to speaker.
- g. Steps c-f were repeated.

Report No.: CEBDBO-WTW-P21115053 Page No. 12 / 77 Report Format Version: 7.1.0



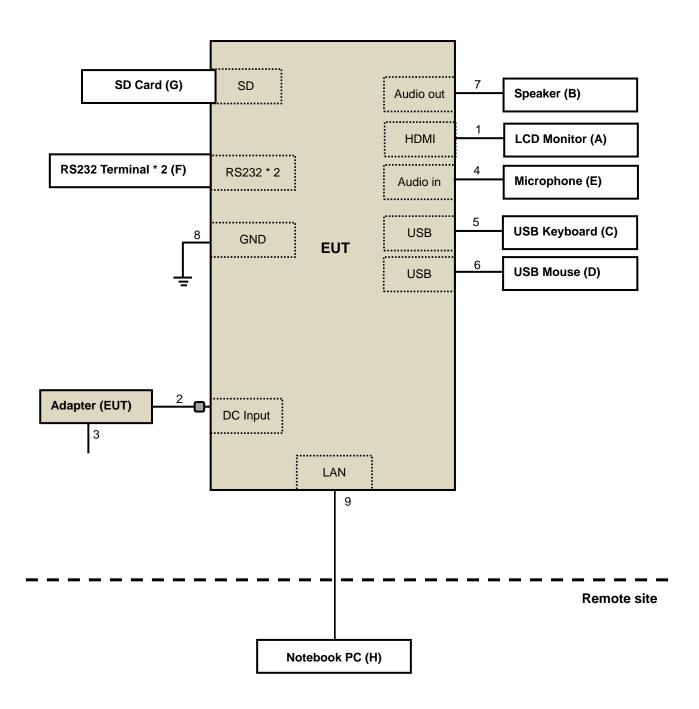
3.6 Connection Diagram of EUT and Peripheral Devices

Emission tests (Harmonics & Flicker excluded):





Harmonics & Flicker & Immunity tests:





3.7 Configuration of Peripheral Devices and Cable Connections

Emission tests (Harmonics & Flicker excluded):

ID	Product	Brand	Model No.	Serial No.	FCC ID	Remarks
A.	LCD Monitor	ASUS	MG28UQ	H8LMTF147974	NA	Provided by Lab
B.	SD Card	SP	N/A	N/A	N/A	Provided by Lab
C.	USB Keyboard	Dell	KB216t	CN-0W33XP-LO300-7C L-190A	NA	Provided by Lab
D.	USB Mouse	DELL	MOCZUL	CN-049TWY-PRC00-77 B-007F	NA	Provided by Lab
E.	RS232 Terminal* 2	NA	NA	NA	NA	Supplied by client
F.	EARPHONE	PHILIPS	SBC HL145	NA	NA	Provided by Lab
G.	Microphone	E-BOOKS	E-EPB099	N/A	N/A	Provided by Lab
Н.	Notebook PC	LENOVO	T480	PF1EZSA2	NA	Provided by Lab

ID	Cable Descriptions	Qty.	Length (m)	Shielding (Yes/No)	Cores (Qty.)	Remarks
1.	HDMI cable	1	2.0	Υ	0	Provided by Lab
2.	DC power cable	1	1.5	N	1	Supplied by client
3.	AC power cable	1	1.8	N	0	Provided by Lab
4.	Audio cable	1	1.8	N	0	Provided by Lab
5.	USB cable	1	1.8	Υ	0	Provided by Lab
6.	USB cable	1	1.8	Υ	0	Provided by Lab
7.	Audio cable	1	1.5	N	0	Provided by Lab
8.	GND cable	1	1.5	N	0	Provided by Lab
9.	LAN cable	1	10	Y	0	Provided by Lab (RJ45, Cat.5e)

Harmonics, Flicker, Immunity tests:

ID	Product	Brand	Model No.	Serial No.	FCC ID	Remarks
A.	LCD Monitor	ASUS	VS197D	CBLMTF046363	FCC DoC Approved	Provided by Lab
B.	Speaker	NA	NA	NA	NA	Provided by Lab
C.	USB Keyboard	DELL	KB4021	CN-05V23T-71581-1AK- 00MT-A01	FCC DoC Approved	Provided by Lab
D.	USB Mouse	Ronail	SYS118	NA	NA	Provided by Lab
E.	Microphone	E-BOOKS	E-EPB099	N/A	N/A	Provided by Lab
F.	RS232 Terminal* 2	NA	NA	NA	NA	Supplied by client
G.	SD Card	SP	N/A	N/A	N/A	Provided by Lab
Н.	Notebook PC	Dell	E5430	7QVMZW1	FCC DoC Approved	Provided by Lab

ID	Cable Descriptions	Qty.	Length (m)	Shielding (Yes/No)	Cores (Qty.)	Remarks
1.	HDMI cable	1	2.0	Υ	0	Provided by Lab
2.	DC power cable	1	1.5	Ν	1	Supplied by client
3.	AC power cable	1	1.8	Ν	0	Provided by Lab
4.	Audio cable	1	1.8	N	0	Provided by Lab
5.	USB cable	1	1.8	Υ	0	Provided by Lab
6.	USB cable	1	1.8	Υ	0	Provided by Lab
7.	Audio cable	1	1.5	N	0	Provided by Lab
8.	GND cable	1	1.5	Ν	0	Provided by Lab
9.	LAN cable	1	10	Υ	0	Provided by Lab (RJ45, Cat.5e)

Report No.: CEBDBO-WTW-P21115053 Page No. 15 / 77 Report Format Version: 7.1.0



4 Test Instruments

The calibration interval of the all test instruments are 12 months and the calibrations are traceable to NML/ROC and NIST/USA.

4.1 Conducted Emissions from Power Ports

Description & Manufacturer	Model no.	Serial No.	Calibrated Date	Calibrated Until
Test Receiver ESR3 R&S	ESR3	102412	2021/1/29	2022/1/28
LISN SCHWARZBECK	NSLK 8128	8128-244	2021/11/11	2022/11/10
LISN SCHWARZBECK	NNLK8129	8129229	2021/5/20	2022/5/19
DC LISN SCHWARZBECK	NNLK 8121	8121-808	2021/4/18	2022/4/17
LISN SCHWARZBECK	NNLK 8121	8121-731	2021/4/28	2022/4/27
LISN R&S	ENV216	101196	2021/4/26	2022/4/25
LISN R&S	ESH3-Z5	100220	2021/11/25	2022/11/24
LISN R&S	ESH3-Z6	844950/018	2021/7/25	2022/7/24
DC LISN R&S	ESH3-Z6	100219	2021/7/25	2022/7/24
High Voltage Probe Schwarzbeck	TK9420	00982	2021/1/8	2022/1/7
RF Coaxial Cable Commate	5D-FB	Cable-CO5-01	2021/1/29	2022/1/28
Attenuator STI	STI02-2200-10	NO.4	2021/9/3	2022/9/2
50 Ohms Terminator LYNICS	0900510	E1-01-305	2021/2/17	2022/2/16
Isolation Transformer Erika Fiedler	D-65396	017	2021/9/9	2022/9/8
Software BVADT	Cond_V7.3.7.4	NA	NA	NA

Note: 1. The test was performed in Linkou Conduction 05.

2. The VCCI Site Registration No. C-11093.

3. Tested Date: 2021/12/2

Report No.: CEBDBO-WTW-P21115053 Page No. 16 / 77 Report Format Version: 7.1.0



4.2 **Conducted Emissions from Wired Network Ports**

Description & Manufacturer	Model No.	Serial No.	Calibrated Date	Calibrated Until
Test Receiver ESR3 R&S	ESR3	102412	2021/1/29	2022/1/28
LISN SCHWARZBECK	NSLK 8128	8128-244	2021/11/11	2022/11/10
LISN SCHWARZBECK	NNLK8129	8129229	2021/5/20	2022/5/19
DC LISN SCHWARZBECK	NNLK 8121	8121-808	2021/4/18	2022/4/17
LISN SCHWARZBECK	NNLK 8121	8121-731	2021/4/28	2022/4/27
LISN R&S	ENV216	101196	2021/4/26	2022/4/25
LISN R&S	ESH3-Z5	100220	2021/11/25	2022/11/24
RF Coaxial Cable Commate	5D-FB	Cable-CO5-01	2021/1/29	2022/1/28
50 Ohms Terminator LYNICS	0900510	E1-01-305	2021/2/17	2022/2/16
Isolation Transformer Erika Fiedler	D-65396	017	2021/9/9	2022/9/8
ISN FCC	F-071115-1057-1	20650	2021/2/3	2022/2/2
ISN FCC	F-071115-1057-1	20651	2021/3/10	2022/3/9
ISN FCC	F-071115-1057-1	20652	2021/1/18	2022/1/17
ISN FCC	F-071115-1057-1-09	120033	2021/5/12	2022/5/11
Impedance-stabilization-network TESEQ	ISN T8-Cat6	53159	2021/3/16	2022/3/15
ISN TESEQ	ISN S751	40599	2021/7/27	2022/7/26
ISN TESEQ	ISN ST08	41212	2021/8/8	2022/8/7
Impedance-stabilization-network TESEQ	ISN T400A	28573	2021/8/8	2022/8/7
Impedance-stabilization-network TESEQ	ISN T800	36181	2021/8/6	2022/8/5
RF Current Probe FCC	F-33-4	56	2021/7/27	2022/7/26
Software BVADT	ISN_V7.3.7.4	NA	NA	NA

Note: 1. The test was performed in Linkou Conduction 05 (ISN 05). 2. The VCCI Site Registration T-20058.

3. Tested Date: 2021/12/2

Report No.: CEBDBO-WTW-P21115053 Page No. 17 / 77 Report Format Version: 7.1.0



4.3 Radiated Emissions up to 1 GHz

Description & Manufacturer	Model No.	Serial No.	Calibrated Date	Calibrated Until
TEST RECEIVER R&S	ESCS 30	100292	2021/9/1	2022/8/31
TEST RECEIVER R&S	ESCS 30	100276	2021/4/15	2022/4/14
Bi-log Broadband Antenna Schwarzbeck	VULB9168	9168-303	2021/10/29	2022/10/28
Pre_Amplifier HP	8447D	2944A08119	2021/2/18	2022/2/17
RF Coaxial Cable Pacific	8D-FB	Cable-ST2-01	2021/10/22	2022/10/21
Attenuator Mini-Circuits	UNAT-5+	PAD-ST2-01	2021/10/22	2022/10/21
ADT. Turn Table	TT100	0205	NA	NA
ADT. Tower	AT100	0205	NA	NA
Software BVADT	Radiated_V7.6.15.9.5	NA	NA	NA

Note:

- 1. The test was performed in Linkou Open Site2 , The test site validated date: 2021/07/30(NSA)
- 2. The VCCI Site Registration No. R-10237.
- 3. Tested Date: 2021/12/1

Report No.: CEBDBO-WTW-P21115053 Page No. 18 / 77 Report Format Version: 7.1.0



4.4 **Radiated Emissions above 1 GHz**

Description & Manufacturer	Model No.	Serial No.	Calibrated Date	Calibrated Until
Spectrum Analyzer Agilent	E4446A	MY51100009	2021/6/29	2022/6/28
Test Receiver Agilent	N9038A	MY51210137	2021/6/16	2022/6/15
Pre-amplifier HP	8449B	3008A01292	2021/2/19	2022/2/18
Pre_Amplifier EMCI	EMC0126545	980076	2021/2/19	2022/2/18
HORN Antenna ETS	3117-PA	00215857	2021/11/14	2022/11/13
Antenna(Horn) EMCO	3115	6714	2021/11/14	2022/11/13
Pre_Amplifier MITEQ	AMF-6F-260400-33-8P	892164	2021/2/19	2022/2/18
Pre_Amplifier EMCI	EMC184045B	980235	2021/2/19	2022/2/18
Broadband Horn Antenna Schwarzbeck	BBHA 9170	212	2021/10/13	2022/10/12
RF Coaxial Cable Rosnol	K1K50-UP0279-K1K50-30 00	Cable-CH10(3m) -04	2021/7/8	2022/7/7
RF Coaxial Cable WOKEN	WC01	Cable-CH10-03	2021/7/8	2022/7/7
Attenuator Mini-Circuits	BW-N4W5+	PAD-CH10-02	2021/7/8	2022/7/7
Attenuator Mini-Circuits	BW-K3-2W44+	PAD-CH7-03	2021/7/8	2022/7/7
BandPass Filter MICRO-TRONICS	BRM17690	005	2021/5/28	2022/5/27
Notch filter MICRO-TRONICS	BRC50703-01	010	2021/5/28	2022/5/27
Turn Table & Tower Max Full	MF7802	MF780208216	NA	NA
Software BVADT	Radiated_V8.7.08	NA	NA	NA

Note:

- The test was performed in Linkou 966 Chamber3(CH10)
 The VCCI Site Registration No. G-10427
- 3. Tested Date: 2021/12/2

Report No.: CEBDBO-WTW-P21115053 Page No. 19 / 77 Report Format Version: 7.1.0



4.5 Harmonics Current Measurement

Description & Manufacturer	Model No.	Serial No.	Calibrated Date	Calibrated Until
Harmonics and Flicker Analyzer TESEQ	PROFLINE 2105	1632A00983&1639A 01863	2021/6/8	2022/6/7
Software	CTS 4	NA	NA	NA

Note: 1. The test was performed in EMS Room No. 1.

2. Tested Date: 2021/12/7

4.6 Voltage Fluctuations and Flicker Measurement

Description & Manufacturer	Model No.	Serial No.	Calibrated Date	Calibrated Until
Harmonics and Flicker Analyzer TESEQ	PROFLINE 2105	1632A00983&1639A 01863	2021/6/8	2022/6/7
Software	CTS 4	NA	NA	NA

Note: 1. The test was performed in EMS Room No. 1.

2. Tested Date: 2021/12/7

4.7 Electrostatic Discharge (ESD)

Description & Manufacturer	Model No.	Serial No.	Calibrated Date	Calibrated Until
ESD Simulator KeyTek	MZ15/EC	0504259	2021/11/10	2022/11/9
ESD Simulator KeyTek	MZ-15/EC	0401299	2021/10/7	2022/10/6
ESD Simulator TESEQ	NSG 438	1364	2020/12/11	2021/12/10
Electronic Discharge Simulator Noiseken	ESS-2000	ESS0382041	2021/10/7	2022/10/6
ESD Generator EM Test	Dito//DM-150/330//DM-150/3 30-rfci	P1315117252/P1317117852	2021/7/9	2022/7/8

Note: 1. The test was performed in Linkou ESD 01.

2. Tested Date: 2021/12/10

 Report No.: CEBDBO-WTW-P21115053
 Page No. 20 / 77
 Report Format Version: 7.1.0



4.8 Radio Frequency Electromagnetic Field (RS)

Description & Manufacturer	Model No.	Serial No.	Calibrated Date	Calibrated Until
Signal Generator Agilent	E8257D	MY48050465	2021/6/22	2022/6/21
Amplifier BONN	BSA 0125-800	1912556	NA	NA
Amplifier TESTQ	CBA 1G-275	T44344	NA	NA
Power Amplifier AR	35S4G8AM4	0326094	NA	NA
Power Amplifier AR	100S1G4M3	0329249	NA	NA
Controller AR	SC1000M3	305910	NA	NA
RF Power meter BOONTON	4232A	10180	2021/5/24	2022/5/23
Power sensor BOONTON	51011-EMC	34152	2021/5/24	2022/5/23
Power sensor BOONTON	51011-EMC	34153	2021/5/24	2022/5/23
Log-Periodic Antenna AR	AT6080	0329465	NA	NA
BiconiLog Antenna EMCO	3141	1001	NA	NA
High Gain Horn Antenna AR	AT4010	0329800	NA	NA
LOG ANTENNA Schwarzbeck	Schwarzbeck Stlp 9149	9149-260	NA	NA
CHANCE MOST Full Anechoic Chamber (9x5x3m)	Chance Most	RS-002	2021/2/4	2022/2/3
Software BVADT	RS_V7.6	NA	NA	NA
Audio analyzer R&S	UPV	104565	2021/5/18	2022/5/17
Ear Simulator Telephonometry B&K	4185	2553594	NA	NA
Pressure-field Microphone B&K	4192	3190854	2021/1/7	2022/1/6
Two channel microphone conditioning amplifier B&K	2690 A OS2	2645274	2021/5/16	2022/5/15
POWER AMPLIFIER B&K	2716C	2610979	NA	NA
Mouth Simulator B&K	4227	2630632	NA	NA
Software	ABMS_ V7.4.3	NA	NA	NA

Note: 1. The test was performed in RS Room No.2.

2. Tested Date: 2021/12/10



4.9 **Fast Transients Common Mode (EFT)**

Description & Manufacturer	Model No.	Serial No.	Calibrated Date	Calibrated Until
Burst generator Haefely	PEFT 4010	154954	2021/4/7	2022/4/6

1. The test was performed in EFT Room Note:

2. Tested Date: 2021/12/7

4.10 Surge

Description & Manufacturer	Model No.	Serial No.	Calibrated Date	Calibrated Until
Surge&EFT Generators TESEQ	NSG 3060	1572	2021/4/24	2022/4/23
Coupling Decoupling Network	CDN-UTP8	045	NA	NA
Coupling Decoupling Network TESEQ		41009	NA	NA
Surge Coupling Decoupling Network TESEQ	CDN 118-T8	40386	2021/9/9	2022/9/8
CDN for Unshielded Unsymmetrical Signal & Data Lines TESEQ		40144	2021/9/9	2022/9/8

 The test was performed in Linkou EMS 02.
 Tested Date: 2021/12/8 Note:

Report No.: CEBDBO-WTW-P21115053 Page No. 22 / 77 Report Format Version: 7.1.0



4.11 Radio Frequency Common Mode (CS)

Description & Manufacturer	Model No.	Serial No.	Calibrated Date	Calibrated Until
R&S SML03 S.G R&S	SML03	101801	2021/1/13	2022/1/12
Amplifier AR	75A250AM1	306331	NA	NA
Digital Sweep Function Generator Topward	8120	984801	NA	NA
Power Sensor R & S	NRV-Z5	837878/039	2021/10/19	2022/10/18
Power Meter R & S	NRVD	837794/040	2021/10/19	2022/10/18
FCC EM Injection Clamp FCC	F-203I-23mm	455	NA	NA
Current Clamp FCC	F-120-9A	361	2021/8/8	2022/8/7
Coupling/Dcoupling Network EM TEST	CDN M1/32A	306508	2021/6/17	2022/6/16
CDN M2-16Amp FCC	FCC-801-M2-16A	01047	2021/6/17	2022/6/16
Coupling/Dcoupling Network TESEQ	CDN M232	37702	2021/6/17	2022/6/16
Coupling/Dcoupling Network TESEQ	CDN M332	41258	2021/6/17	2022/6/16
Coupling/Dcoupling Network TESEQ	CDN M332	41256	2021/6/17	2022/6/16
Coupling Decoupling Network TESEQ	CDN M432S	56519	2021/2/25	2022/2/24
CDN FCC	FCC-801-M5-50A	100018	2021/1/19	2022/1/18
Coupling Decoupling Network TESEQ	CDN T2A-10	54942	2021/2/25	2022/2/24
Coupling Decoupling Network TESEQ	CDN T400A	49918	2021/2/25	2022/2/24
Coupling Decoupling Network TESEQ	CDN T800	34428	2021/6/17	2022/6/16
Coupling Decoupling Network TESEQ	CDN T8-10	40376	2021/6/17	2022/6/16
Coupling Decoupling Network TESEQ	CDN T8-230	56641	2021/2/25	2022/2/24
Coupling Decoupling Network TESEQ	CDN T8-230	56642	2021/2/25	2022/2/24
Coupling Decoupling Network TESEQ	CDN T8-230	56643	2021/2/25	2022/2/24
CDN Calibration Kit TESEQ	CDN T8S	29459	2021/6/17	2022/6/16
Coupling Decoupling Network TESEQ	CDN ST08A	56527	2021/2/25	2022/2/24
Coupling Decoupling Network TESEQ	CDN ST08A	56525	2021/2/25	2022/2/24
CDN TESEQ	CDN S200	53490	2021/5/26	2022/5/25
CDN TESEQ	CDN S400	52115	2021/6/17	2022/6/16
Coupling Decoupling Network TESEQ	CDN S751A	56435	2021/2/25	2022/2/24
Coupling Decoupling Network TESEQ	CDN S751A	56436	2021/2/25	2022/2/24



Software BVADT	CS_V7.4.2	NA	NA	NA
Audio analyzer R&S	UPV	104565	2021/5/18	2022/5/17
Ear Simulator Telephonometry B&K	4185	2553594	NA	NA
Pressure-field Microphone B&K	4192	3073928	2021/8/12	2022/8/11
Two channel microphone conditioning amplifier B&K	2690 OS2	3001996	2021/11/17	2022/11/16
POWER AMPLIFIER B&K	2716C	2610979	NA	NA
Mouth Simulator B&K	4227	2630632	NA	NA
Software BVADT	ABMS_ V7.4.3	NA	NA	NA

Note: 1. The test was performed in CS Room No. 1.

2. Tested Date: 2021/12/9

4.12 Power Frequency Magnetic Field (PFMF)

Description & Manufacturer	Model No.	Serial No.	Calibrated Date	Calibrated Until
Magnetic Field Test System Haefely Trench AG	MAG 100	083794-06	NA	NA
F.W.BELL 4190 Gaussmeter F.W. Bell	4190	0743043	2021/4/8	2022/4/7

Note: 1. The test was performed in Linkou EMS1

2. Tested Date: 2021/12/7

4.13 Voltage Dips and Interruptions (DIP)

Description & Manufacturer	Model No.	Serial No.	Calibrated Date	Calibrated Until
Harmonics and Flicker Analyzer TESEQ	PROFLINE 2105	1632A00983&1639 A01863	2021/6/8	2022/6/7
EMS Simulator KeyTek	EMCPro	9902207	2021/5/7	2022/5/6
Software	WIN2120	NA	NA	NA

Note: 1. The test was performed in Linkou EMS1

2. Tested Date: 2021/12/7



5 Limits of Test Items

For equipment intended to be used exclusively in an industrial environment or a telecommunication centre the class A limits can be used.

5.1 Conducted Emissions from Power Ports

For AC mains power input/output Port

Frequency (MHz)		Class A (dBµV)		Class B (dBµV)	
Freque	ency (winz)	Quasi-peak	Average	Quasi-peak	Average
0.1	15 - 0.5	79	66	66 - 56	56 - 46
0.5	50 - 5.0	73	60	56	46
5.0	0 - 30.0	73	60	60	50

Notes: 1. The lower limit shall apply at the transition frequencies.

5.2 Conducted Emissions from Wired Network Ports

		Cla	ss A		
Frequency (MHz)	Coupling Device	Voltage Li	mit (dBuV)	Current lim	its (dBuA)
Frequency (MHZ)	Coupling Device	Quasi-peak	Average	Quasi-peak	Average
0.15 - 0.5	AAN	97 - 87	84 - 74	-	-
0.5 - 30	AAN	87	74	-	-
0.15 - 0.5	CVP and	97 - 87	84 - 74	53 - 43	40 - 30
0.5 - 30	Current probe	87	74	43	30
0.15 - 0.5	Current Probe	-	-	53-43	40 - 30
0.5 - 30		-	-	43	30
		Cla	ss B		
Гто с с. с	Counting Daviso	Voltage Li	mit (dBuV)	Current lim	its (dBuA)
Frequency (MHz)	Coupling Device	Quasi-peak	Average	Quasi-peak	Average
0.15-0.5	A A N I	84 - 74	74 - 64	-	-
0.5-30	AAN	74	64	-	-
0.15-0.5	CVP and	84 - 74	74 - 64	40 - 30	30 - 20
0.5-30	Current probe	74	64	30	20
0.15-0.5	Current Droke	-	-	40 - 30	30 - 20
0.5-30	Current Probe	-	-	30	20

Note: The limits decrease linearly with the logarithm of the frequency in the range 0.15 MHz to 0.5 MHz.

5.3 Radiated Emissions up to 1 GHz

Fragues et (MHz)	Class A (dBuV/m)		Class B (dBuV/m)	
Frequency (MHz)	at 3m	at 10m	at 3m	at 10m
30 - 230	50	40	40	30
230 - 1000	57	47	47	37

Notes: 1. The lower limit shall apply at the transition frequencies.

- 2. Emission level (dBuV/m) = 20 log Emission level (uV/m).
- 3. All emanations from a class A/B digital device or system, including any network of conductors and apparatus connected thereto, shall not exceed the level of field strengths specified above.

Report No.: CEBDBO-WTW-P21115053 Page No. 25 / 77 Report Format Version: 7.1.0

^{2.} The limit decreases linearly with the logarithm of the frequency in the range of 0.15 to 0.50 MHz.



5.4 Radiated Emissions above 1 GHz

Frequency (GHz)	Class A (dBuV/m) (at 3m)		Class B (dBuV/m) (at 3m)	
Frequency (GHz)	Average	Peak	Average	Peak
1 to 3	56	76	50	70
3 to 6	60	80	54	74

Notes: 1. The lower limit shall apply at the transition frequencies.

- 2. Emission level (dBuV/m) = 20 log Emission level (uV/m).
- 3. All emanations from a class A/B digital device or system, including any network of conductors and apparatus connected thereto, shall not exceed the level of field strengths specified above.

Frequency Range of Radiated Measurement (For unintentional radiators)

Highest internal frequency (Fx)	Highest measurement frequency (FM)		
(MHz)	(GHz)		
F x ≤ 108 MHz	1		
108 MHz < Fx ≤ 500 MHz	2		
500 MHz < Fx ≤ 1 GHz	5		
Fx > 1 GHz 5 x Fx up to a maximum of 6 GHz			
Fx is the highest fundamental frequency generated and/or used in the ITE or digital apparatus under test.			

Report No.: CEBDBO-WTW-P21115053 Page No. 26 / 77 Report Format Version: 7.1.0



5.5 Harmonic Current Measurement

Limits for Class A equipment				
Harmonic	Max. permissible harmonics			
Order	current			
n	A			
	Odd harmonics			
3	2.30			
5	1.14			
7	0.77			
9	0.40			
11	0.33			
13	0.21			
15≦n≦39	0.15x15/n			
	Even harmonics			
2	1.08			
4	0.43			
6	0.30			
8≦n≦40	0.23x8/n			

	Limits for Class D equipment						
Harmonic Order n	Max. permissible harmonics current per watt mA/W	Max. permissible harmonics current A					
	Odd Harmonics only	1					
3	3.4	2.30					
5	1.9	1.14					
7	1.0	0.77					
9	0.5	0.40					
11	0.35	0.33					
13	0.30	0.21					
15≦n≦39	3.85/n	0.15x15/n					

Note: 1. Class A and Class D are classified according to section 5 of EN 61000-3-2.

Classification of equipment

Oldoonloation of equipment			
Class A	Class B	Class C	Class D
Balanced three-phase equipment;	Portable tools;	Lighting	Equipment having a specified power less
Household appliances excluding	Arc welding	equipment.	than or equal to 600 W of the following
equipment as Class D;	equipment which is		types:
Tools excluding portable tools;	not professional		Personal computers and personal
Dimmers for incandescent lamps;	equipment.		computer monitors;
Audio equipment;			Television receivers;
Equipment not specified in one of the			Refrigerators and freezers having one or
three other classes.			more variable-speed drives to control
			compressor motor(s).

^{1.} According to section 7 of EN 61000-3-2, the above limits for all equipment except for lighting equipment having an active input power > 75 W and no limits apply for equipment with an active input power up to and including 75 W.



5.6 Voltage Fluctuations and Flicker Measurement

Test Item	Limit	Note		
P _{st}	1.0	P _{st} means short-term flicker indicator.		
P _{lt}	0.65	P _{It} means long-term flicker indicator.		
T _{dt} (ms)	500	T _{dt} means maximum time that d(t) exceeds 3.3 %.		
d _c (%)	3.3%	d₀ means relative steady-state voltage change		
	d _{max} means maximum relative voltage change. Control Method of Equipment (see below)			
	4%	- without additional conditions		
d _{max} (%)	- switched manually, or - switched automatically more frequently than twice per day, and also has e a delayed restart (the delay not less than a few tens of seconds), or manu restart, after a power supply interruption			
	7%	 - attended whilst in use (for example: hair dryers, vacuum cleaners, kitchen equipment such as mixers, garden equipment such as lawn mowers, portable tools such as electric drills), or switched on automatically, or - is intended to be switched on manually, no more than twice per day, and also has either a delayed restart (the delay being not less than a few tens of seconds) or manual restart, after a power supply interruption. 		



5.7 General immunity requirements

Port	Basic Standard	Test item	Test specification	Performance criteria
Power input (AC)	IEC 61000-4-4	Fast Transients, Common Mode (EFT)	±1 kV 5/50 ns (Tr/Th) 5 kHz, repetition frequency	В
	IEC 61000-4-5	Surge	Line to line: ±1 kV, 1.2/50 μs Line to earth: ±2 kV, 1.2/50 μs	В
	IEC 61000-4-6	Radio Frequency, Common Mode (CS)	0.15-10 MHz, 3V, 80% AM (1kHz), 10-30 MHz, 3V-1V, 80% AM (1kHz), 30-80 MHz, 1V, 80% AM (1kHz),	А
	IEC 61000-4-11	Voltage dips and interruptions (DIP)	Voltage Dips: < 5 % residual voltage, 0.5 cycle 70% residual voltage, 25 cycles (at 50Hz) Voltage Interruption: < 5 % residual voltage, 250 cycles (at 50 Hz)	B C C
DC power/ Wired network and Signal/ Control port	IEC 61000-4-4	Fast Transients Common Mode (EFT)	±0.5 kV 5/50 ns (Tr/Th) 100 kHz, repetition frequency for xDSL port 5 kHz, repetition frequency for other port	В
	IEC 61000-4-5	Surge	Wired network ports (directly connected to outdoor cables): Symmetrically operated: 10/700µs w/o primary protectors: ±1.0kV, or with primary protectors fitted: ±1.0kV and ±4.0kV,	С
			Coaxial or shielded operated: 1.2/50µs shield to ground: ±0.5 kV,	В
			DC power ports (directly connected to outdoor cables): 1.2/50 μs each individual line to earth, or shield to ground: ±0.5 kV,	В
	IEC 61000-4-6	Radio Frequency Common Mode (CS)	0.15-10 MHz, 3V, 80% AM (1kHz), 10-30 MHz, 3V-1V, 80% AM (1kHz), 30-80 MHz, 1V, 80% AM (1kHz),	А
		Broadband impulse noise disturbances (Applicable only to xDSL ports.)	Repetitive: Impulse frequency profile: 0.15 – 0.5 MHz, 107 dBuV; 0.5 – 10 MHz, 107 – 36 dBuV; 10 – 30 MHz, 36 – 30 dBuV Burst duration: 0.70 ms Burst period: 10 ms(for 50 Hz)	A
			At least 2 minutes for each port under test. Isolated: Impulse frequency profile: 0.15 –30 MHz, 110 dBuV Burst duration: 0.24 ms, 10 ms and 300 ms Isolated impulses: 5 times Interval: at least 60 seconds	В



Port	Basic Standard	Test item	Test specification	Performance criteria
Enclosure	IEC 61000-4-2	Electrostatic Discharge (ESD)	±4 kV (contact) ±8 kV (Air)	В
	IEC 61000-4-3	Radio Frequency Electromagnetic Field (RS)	Swept Frequency Test: 80 to 1000(MHz), 3 V/m, 80 % AM (1 kHz) Spot Frequency Test: 1800, 2600, 3500, 5000 MHz (±1 %), 3V/m, 80% AM (1kHz)	A
	IEC 61000-4-8	Power Frequency Magnetic Field (PFMF)	1A/m, 50Hz	А

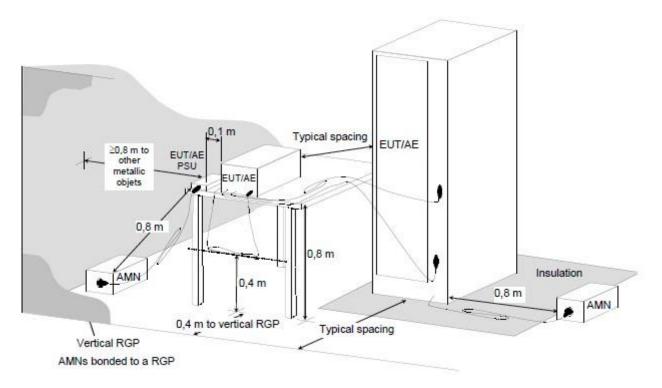


6 Test Arrangements

6.1 Conducted Emissions from Power Ports

- a. The EUT is placed 0.4 meters from the conducting wall of the shielded room with EUT being connected to the power mains through a line impedance stabilization network (LISN), or an Artificial Network (AN) as specified in CISPR 25 if uses in a vehicle. Other support units are connected to the power mains through another LISN and/or AN. They provide coupling impedance for the measuring instrument.
- b. Both lines of the power mains connected to the EUT were checked for maximum conducted interference.
- c. The test results of conducted emissions at mains ports are recorded of six worst margins for quasi-peak (mandatory) [and average (if necessary)] values against the limits at frequencies of interest unless the margin is 20 dB or greater.

Note: The resolution bandwidth and video bandwidth of test receiver is 9kHz for quasi-peak detection (QP) and average detection (AV) at frequency 0.15MHz-30MHz.



For the actual test configuration, please refer to the related Item – Photographs of the Test Configuration.

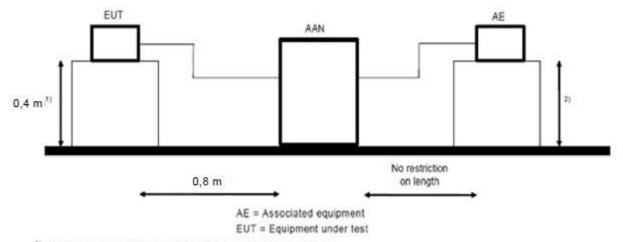


6.2 Conducted Emissions from Wired Network Ports

Method of Using AANs:

- a. The EUT is placed 0.4 meters from the conducting wall of the shielded room and connected to AAN directly to reference ground plane.
- b. If voltage measurement is used, measure voltage at the measurement port of the AAN, correct the reading by adding the AAN voltage division factor, and compare to the voltage limit.
- c. It is not necessary to apply the current limit if a AAN is used.
- d. The test results of disturbance at telecommunication ports are recorded of six worst margins for quasi-peak (mandatory) [and average (if necessary)] values against the limits at frequencies of interest unless the margin is 20 dB or greater.

Note: The resolution bandwidth and video bandwidth of test receiver is 9kHz for quasi-peak detection (QP) and average detection (AV) at frequency 0.15MHz-30MHz.



Distance to the reference groundplane (vertical or horizontal).

For the actual test configuration, please refer to the related Item – Photographs of the Test Configuration.

Report No.: CEBDBO-WTW-P21115053 Page No. 32 / 77 Report Format Version: 7.1.0

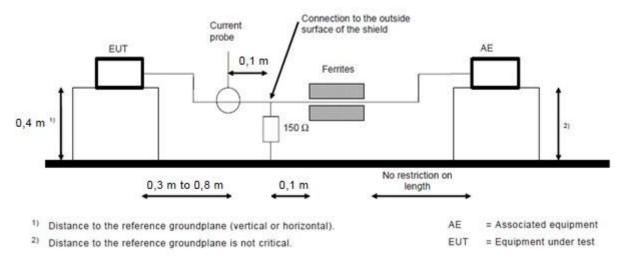
²⁾ Distance to the reference groundplane is not critical.



Method of Using a 150 Ω load to the outside surface of the shielding cable:

- a. Breaks the external protective insulation (exposing the shield) and connect a 150Ω resistor from the outside surface of the shield to ground.
- b. A current probe shall be placed at 0.1 m from the 150Ω resistor. The current probe to EUT horizontal distance is between 0.3 m to 0.8 m.
- c. If current measurement is used, measure current at the measurement port of the current probe, correct the reading by adding the current probe division factor, and compare to the current limit.
- d. It is not necessary to apply the voltage limit if a current probe is used.
- e. The test results of disturbance at telecommunication ports are recorded of six worst margins for quasi-peak (mandatory) [and average (if necessary)] values against the limits at frequencies of interest unless the margin is 20 dB or greater.

Note: The resolution bandwidth and video bandwidth of test receiver is 9kHz for quasi-peak detection (QP) and average detection (AV) at frequency 0.15MHz-30MHz.



For the actual test configuration, please refer to the related Item – Photographs of the Test Configuration.

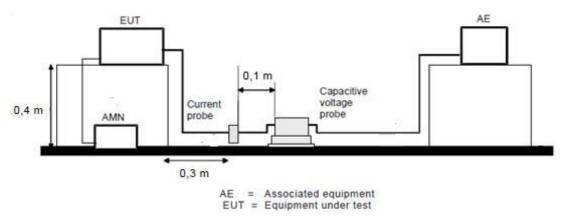
Report No.: CEBDBO-WTW-P21115053 Page No. 33 / 77 Report Format Version: 7.1.0



Method of Using a combination of current probe and capacitive voltage probe:

- a. Measure current with a current probe.
- b. Compare the measured current with the applicable current limit.
- c. Measure voltage with a capacitive voltage probe as specified in 5.2.2 of CISPR 16-1-2.
- d. Adjust the measured voltage as follows:
 - current margin ≤ 6 dB subtract the actual current margin from measured voltage;
 - current margin > 6 dB subtract 6 dB from measured voltage.
- e. Compare adjusted voltage with the applicable voltage limit
- f. Both the measured current and the adjusted voltage shall be below the applicable
- g. The test results of disturbance at telecommunication ports are recorded of six worst margins for quasi-peak (mandatory) [and average (if necessary)] values against the limits at frequencies of interest unless the margin is 20 dB or greater.

Note: The resolution bandwidth and video bandwidth of test receiver is 9kHz for quasi-peak detection (QP) and average detection (AV) at frequency 0.15MHz-30MHz.



For the actual test configuration, please refer to the related Item – Photographs of the Test Configuration.

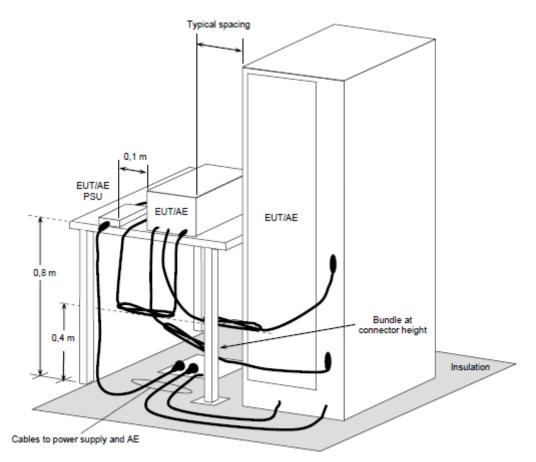
Report No.: CEBDBO-WTW-P21115053 Page No. 34 / 77 Report Format Version: 7.1.0



6.3 Radiated Emissions up to 1 GHz

- a. For the table-top EUT is placed on a 0.8 meter to the top of rotating table; for the the floor standing EUT shall be insulated (by insulation of maximum thickness of 150 mm) from the horizontal reference ground plane. The rotating table is rotated 360 degrees to determine the position of the highest radiation. If the equipment requires a dedicated ground connection, this shall be provided and bonded to the RGP.
- b. The EUT is set 10 meters away from the interference-receiving antenna, which is mounted on the top of a variable-height antenna tower.
- c. The antenna is a broadband antenna, and its height is varied from one meter to four meters above the ground to determine the maximum value of the field strength. Both horizontal and vertical polarizations of the antenna are set to make the measurement.
- d. For each suspected emission, the EUT is arranged to its worst case and then the antenna is tuned to heights from 1 m to 4 m and the rotatable table was turned from 0 degrees to 360 degrees to find the maximum reading.
- e. The test-receiver system is set to quasi-peak detect function and specified bandwidth with maximum hold mode when the test frequency is up to 1 GHz.

Note: The resolution bandwidth and video bandwidth of test receiver/spectrum analyzer is 120kHz for quasi-peak detection (QP) at frequency up to 1GHz.



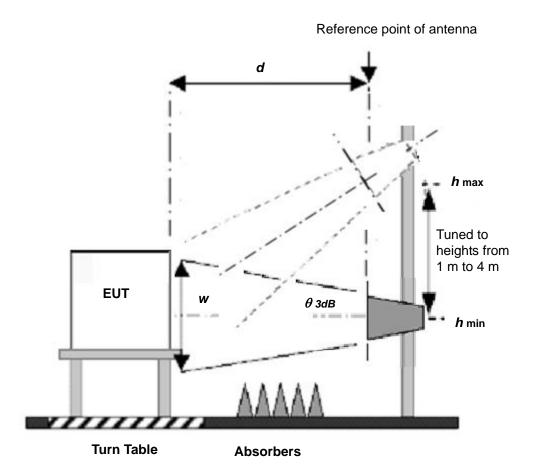
For the actual test configuration, please refer to the related Item – Photographs of the Test Configuration.



6.4 Radiated Emissions above 1 GHz

- a. For the table-top EUT is placed on a 0.8 meter to the top of rotating table; for the the floor standing EUT shall be insulated (by insulation of maximum thickness of 150 mm) from the horizontal reference ground plane. The rotating table is rotated 360 degrees to determine the position of the highest radiation. If the equipment requires a dedicated ground connection, this shall be provided and bonded to the RGP.
- b. The EUT was set d = 3 meters away from the interference-receiving antenna, which was mounted on the top of a variable-height antenna tower.
- c. The height of antenna can be varied from one meter to four meters, the height of adjustment depends on the EUT height and the antenna 3dB beamwidth both, to detect the maximum value of the field strength. Both horizontal and vertical polarizations of the antenna are set to make the measurement.
- d. For each suspected emission, the EUT was arranged to its worst case and then the antenna was tuned to heights and the rotatable table was turned from 0 degrees to 360 degrees to find the maximum reading.
- e. The spectrum analyzer system was set to peak and average detects function and specified bandwidth with maximum hold mode when the test frequency is above 1 GHz.

Note: The resolution bandwidth of test receiver/spectrum analyzer is 1MHz and video bandwidth is 3MHz for Peak detection (PK) at frequency above 1GHz. The resolution bandwidth of test receiver/spectrum analyzer is 1 MHz for Average detection (AV) at frequency above 1GHz.



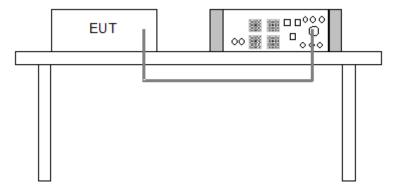
For the actual test configuration, please refer to the related Item – Photographs of the Test Configuration.

Report No.: CEBDBO-WTW-P21115053 Page No. 36 / 77 Report Format Version: 7.1.0



6.5 Harmonics Current Measurement

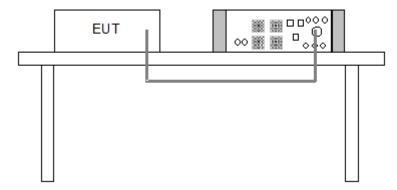
- a. The harmonic current limits apply to line currents and not to currents in the neutral conductor. Nevertheless, for single-phase equipment, it is permissible to measure the currents in the neutral conductor instead of the currents in the line.
- b. The EUT is tested as presented by, and in accordance with information provided by, the manufacturer. Preliminary operation of motor drives by the manufacturer may be needed before the tests are undertaken to ensure that results correspond with normal use.
- c. In all configurations, the use of additional load shall not cause the total output power available to be exceeded.
- d. The correspondent test program of test instrument to measure the current harmonics emanated from EUT is chosen. The measure time shall be not less than the time necessary for the EUT to be exercised.



For the actual test configuration, please refer to the related Item – Photographs of the Test Configuration.

6.6 Voltage Fluctuations and Flicker Measurement

- a. Controls or automatic programs of the EUT shall be set to produce the most unfavourable sequence of voltage changes, using only those combinations of controls and programmes which are mentioned by the manufacturer in the instruction manual, or are otherwise likely to be used.
- b. Preliminary operation of motor drives may be needed before the tests to ensure that results corresponding to those of normal use are obtained.
- c. During the flick measurement, the measure time shall include that part of whole operation cycle in which the EUT produce the most unfavorable sequence of voltage changes. The observation period for short-term flicker indicator is 10 minutes and the observation period for long-term flicker indicator is 2 hours.



For the actual test configuration, please refer to the related Item – Photographs of the Test Configuration.

Report No.: CEBDBO-WTW-P21115053 Page No. 37 / 77 Report Format Version: 7.1.0



6.7 Electrostatic Discharge (ESD)

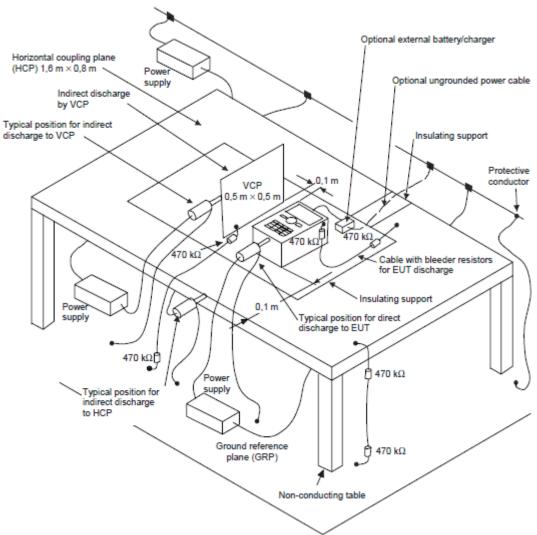
Discharge Impedance:	330 ohm / 150 pF
_	Air – Direct: 10 discharges per location (each polarity)
	Contact – Direct & Indirect: 10 discharges per location (each polarity)
Discharge Period:	1-second minimum

The basic test procedure was in accordance with EN/IEC 61000-4-2:

- a. Electrostatic discharges were applied only to those points and surfaces of the EUT that are accessible to users during normal operation.
- b. The test was performed with at least ten single discharges on the pre-selected points in the most sensitive polarity.
- c. The time interval between two successive single discharges was at least 1 second.
- d. The ESD generator was held perpendicularly to the surface to which the discharge was applied and the return cable was at least 0.2 meters from the EUT.
- e. Contact discharges were applied to the non-insulating coating, with the pointed tip of the generator penetrating the coating and contacting the conducting substrate.
- f. Air discharges were applied with the round discharge tip of the discharge electrode approaching the EUT as fast as possible (without causing mechanical damage) to touch the EUT. After each discharge, the ESD generator was removed from the EUT and re-triggered for a new single discharge. The test was repeated until all discharges were complete.
- g. At least ten single discharges (in the most sensitive polarity) were applied to the Horizontal Coupling Plane at points on each side of the EUT. The ESD generator was positioned at a distance of 0.1 meters from the EUT with the discharge electrode touching the HCP.
- h. At least ten single discharges (in the most sensitive polarity) were applied to the center of one vertical edge of the **Vertical Coupling Plane** in sufficiently different positions that the four faces of the EUT were completely illuminated. The **VCP** (dimensions 0.5m x 0.5m) was placed vertically to and 0.1 meters from the EUT.

Report No.: CEBDBO-WTW-P21115053 Page No. 38 / 77 Report Format Version: 7.1.0





For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.

NOTE:

TABLE-TOP EQUIPMENT

The configuration consisted of a wooden table 0.8 meters high standing on the Ground Reference Plane. The GRP consisted of a sheet of aluminum at least 0.25mm thick, and 2.5 meters square connected to the protective grounding system. A Horizontal Coupling Plane (1.6m x 0.8m) was placed on the table and attached to the GRP by means of a cable with 940k Ω total impedance. The equipment under test, was installed in a representative system as described in section 7 of EN/IEC 61000-4-2, and its cables were placed on the HCP and isolated by an insulating support of 0.5mm thickness. A distance of 1-meter minimum was provided between the EUT and the walls of the laboratory and any other metallic structure.

FLOOR-STANDING EQUIPMENT

The equipment under test was installed in a representative system as described in section 7 of IEC 61000-4-2, and its cables were isolated from the Ground Reference Plane by an insulating support of 0.1-meter thickness. The GRP consisted of a sheet of aluminum that is at least 0.25mm thick, and 2.5 meters square connected to the protective grounding system and extended at least 0.5 m

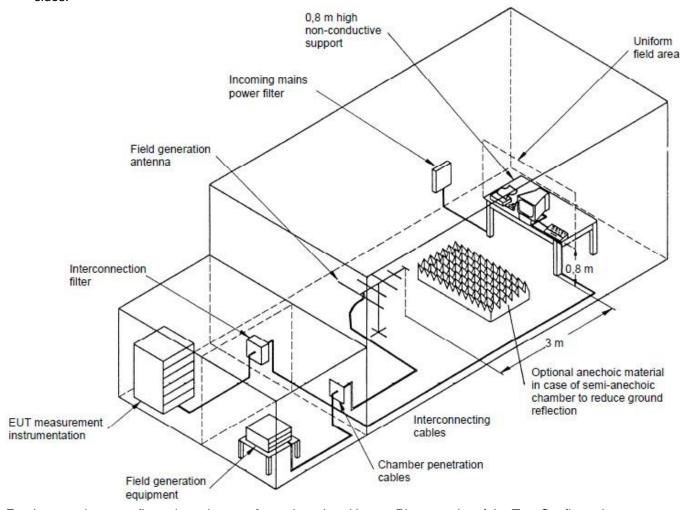


6.8 Radio Frequency Electromagnetic Field (RS)

Modulation:	1kHz Sine Wave, 80%, AM Modulation
Frequency Step:	1 % of preceding frequency value
Dwell Time:	3 seconds

The test procedure was in accordance with EN/IEC 61000-4-3.

- a. The testing was performed in a modified semi-anechoic chamber.
- b. The frequency range shall be swept, with the signal 80% amplitude modulated with a 1kHz sine wave.
- c. The test was performed with the EUT exposed to both vertically and horizontally polarized fields on each of the four sides.



For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.

NOTE:

TABLETOP EQUIPMENT

The EUT installed in a representative system as described in section 7 of EN/IEC 61000-4-3 was placed on a non-conductive table 0.8 meters in height. The system under test was connected to the power and signal wire according to relevant installation instructions.

FLOOR STANDING EQUIPMENT

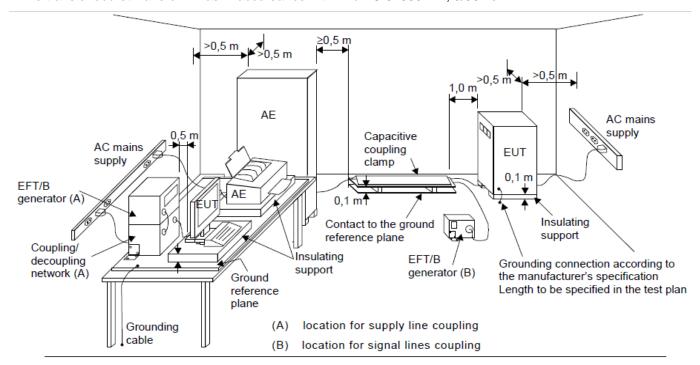
The EUT installed in a representative system as described in section 7 of EN/IEC 61000-4-3 was placed on a non-conductive wood support 0.1 meters in height. The system under test was connected to the power and signal wire according to relevant installation instructions.



6.9 Fast Transients Common Mode (EFT)

Impulse Repetition Frequency:	xDSL telecommunication port: 100kHz others: 5kHz
Impulse Mayo Change	
Impulse Wave Shape:	5/50 ns
Burst Duration:	0.75 ms for 100kHz Repetition Frequency
	15 ms for 5kHz Repetition Frequency
Burst Period:	300 ms
Test Duration:	1 min.

- a. Both positive and negative polarity discharges were applied.
- b. The distance between any coupling devices and the EUT should be 0.5 m for table-top equipment testing, and 1.0 m for floor standing equipment.
- c. The duration time of each test sequential was 1 minute.
- d. The transient/burst waveform was in accordance with EN/IEC 61000-4-4, 5/50 ns.



For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.



6.10 Surge

Pulse Repetition Rate:	20 sec.
Number of Tests:	5 positive and 5 negative at selected points

a. EUT Power ports:

The surge shall be applied to the EUT power supply terminals via the capacitive coupling network. Decoupling networks are required in order to avoid possible adverse effects on equipment not under test that may be powered by the same lines and to provide sufficient decoupling impedance to the surge wave. The power cord between the EUT and the coupling network shall not exceed 2 meters in length.

For double-insulated products without PE or external earth connections, the test shall be done in a similar way as for grounded products but without adding any additional external grounded connections. If there are no other possible connections to earth, line-to-ground tests may be omitted.

b. Wired network ports

Unshielded unsymmetrical interconnection lines:

The coupling / decoupling networks shall not influence the specified functional conditions of the EUT. The interconnection line between the EUT and the coupling network shall not exceed 2 meters in length.

No line-to-ground surges are applied for double-insulated products (i.e. products without any dedicated earth terminal).

Unshielded symmetrical interconnection lines:

For symmetrical interconnection lines and high-speed interconnection lines, the CDN shall be selected to match the number of lines/pairs existing the cable. If coupling arrestors are use, test levels below the ignition point of the coupling arrestor cannot be specified.

The interconnection line between the EUT and the coupling/decoupling networks shall not exceed 2 meters in length.

In order to avoid the coupling and decoupling capacitors having a filtering effect on the data transfer, a balanced high frequency design associating the coupling capacitors with coupling chokes is required. Where normal functioning of high speed communications lines cannot be achieved because of the impact of the CDN on the EUT, product committees should specify appropriate operation or that no surge immunity test is required.

Shielded lines:

The EUT is isolated from ground and the surge is applied to its metallic enclosure; the termination (or auxiliary equipment) at the port(s) under test is grounded. This test applies to equipment with one or more shielded cables.

The length of the cable between the port(s) under test and the device attached to the other end of the cable (AE in Figure 12) shall be:

- 20 m (preferred length) or,
- the shortest length over 10 m, where the manufacturer provides pre-assembled cables used in actual installations.

No test shall be required for cables which according to the manufacturer's specification are ≤ 10 m.

Rules for application of the surge to shielded lines:

- a) Shields grounded at both ends:
- the test shall be carried out.

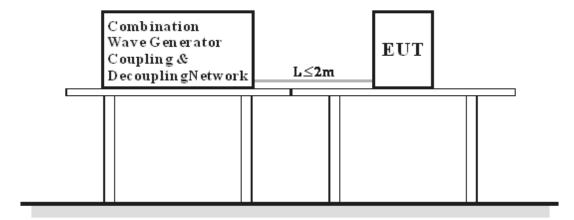
The test level is applied on shields with a 2 Ω generator source impedance and with the 18 μ F capacitor.

- b) Shields grounded at one end:
- the test shall be carried out according to unshielded unsymmetrical interconnection lines or unshielded symmetrical interconnection lines because the shield does not provide any protection against surges induced by magnetic fields.

For EUTs which do not have metallic enclosures, the surge is applied directly to the shielded cable at the EUT side.

Report No.: CEBDBO-WTW-P21115053 Page No. 42 / 77 Report Format Version: 7.1.0





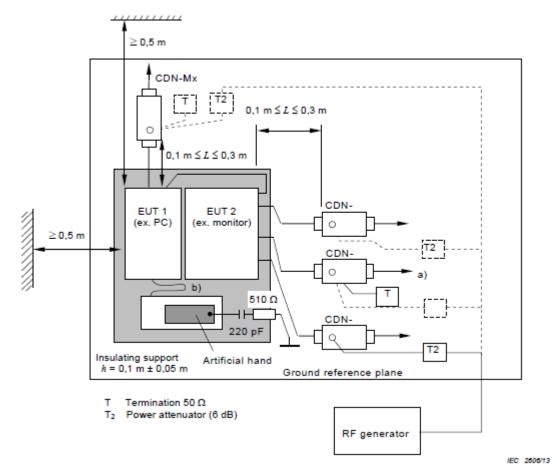
For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.



6.11 Radio Frequency Common Mode (CS)

Modulation:	1kHz Sine Wave, 80%, AM Modulation			
Frequency Step:	1 % of preceding frequency value			
Dwell Time	3 seconds			

- a. The EUT shall be tested within its intended operating and climatic conditions.
- b. An artificial hand was placed on the hand-held accessory and connected to the ground reference plane.
- c. One of the CDNs not used for injection was terminated with 50 ohm, providing only one return path. All other CDNs were coupled as decoupling networks.
- d. The frequency range shall be swept, using the signal level established during the setting process and with a disturbance signal of 80 % amplitude. The signal is modulated with a 1 kHz sine wave, pausing to adjust the RF signal level or the switch coupling devices as necessary. Where the frequency is swept incrementally, the step size shall not exceed 1 % of the preceding frequency value.
- e. Attempts should be made to fully exercise the EUT during testing, and to fully interrogate all exercise modes selected for susceptibility.



Note: 1.The EUT clearance from any metallic obstacles shall be at least 0,5 m.

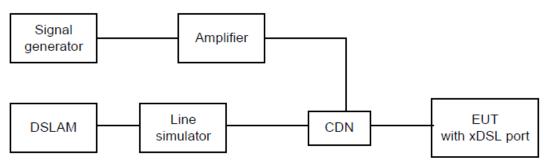
2. Interconnecting cables (≤ 1 m) belonging to the EUT shall remain on the insulating support.

For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.



Broadband impulse noise disturbances, Repetitive and Isolated (Applicable only to xDSL ports.)

- a. The EUT shall be tested within its intended operating and climatic conditions.
- b. An artificial hand was placed on the hand-held accessory and connected to the ground reference plane.
- c. One of the CDNs not used for injection was terminated with 50 ohm, providing only one return path. All other CDNs were coupled as decoupling networks.
- For the repetitive impulse test the disturbance shall be applied for a period of at least 2 minutes for each port under test.
- e. For the isolated impulse test a minimum of 5 isolated impulses shall be applied with an interval of at least 60 seconds between successive impulses.
- f. Attempts should be made to fully exercise the EUT during testing, and to fully interrogate all exercise modes selected for susceptibility.



Example schematic of the broadband impulsive conducted disturbances test setup

For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.

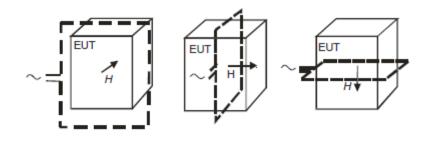
Report No.: CEBDBO-WTW-P21115053 Page No. 45 / 77 Report Format Version: 7.1.0

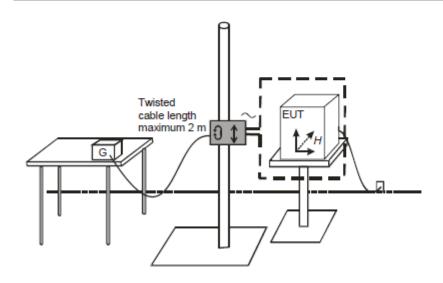


6.12 Power Frequency Magnetic Field (PFMF)

Observation Time:	1 minute
Inductance Coil:	Rectangular coil, 1 m x 1 m (L x W)

- a. The equipment is configured and connected to satisfy its functional requirements.
- b. The power supply, input and output circuits shall be connected to the sources of power supply, control and signal.
- c. The cables supplied or recommended by the equipment manufacturer shall be used. 1 meter of all cables used shall be exposed to the magnetic field.





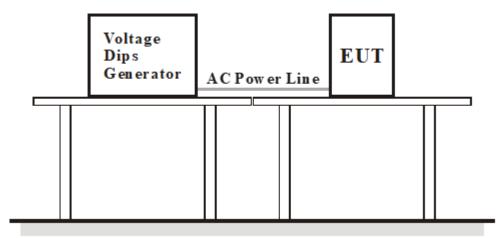
For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.



6.13 Voltage Dips and Interruptions (DIP)

Interval between Event:	10 seconds
Sync Angle (degrees):	0° / 180°
Test Cycle:	3 times

- a. The test shall be performed with the EUT connected to the test generator with the shortest power supply cable as specified by the EUT manufacturer. If no cable length is specified, it shall be the shortest possible length suitable to the application of the EUT.
- b. The EUT shall be tested for each selected combination of test levels and duration with a sequence of 3 dips/interruptions with intervals of 10 s minimum (between each test event). Each representative mode of operation shall be tested. Abrupt changes in supply voltage shall occur at 0 voltage crossover point of the voltage waveform.



For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.



7 Test Results

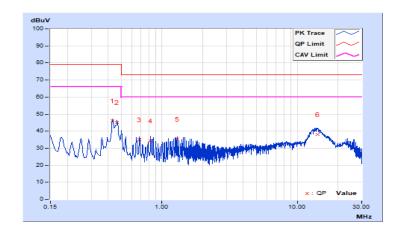
7.1 Conducted emissions from Power Ports

Mode 1

Frequency Range	150kHz ~ 30MHz	Detector Function & Resolution Bandwidth	Quasi-Peak (QP) / Average (AV), 9kHz
Input Power	110Vac, 60Hz	Environmental Conditions	21 °C, 76 % RH
Tested by	Adam Chen		

	Phase Of Power : Line (L)									
No	Frequency	Correction Factor	Reading Value (dBuV)				Limit (dBuV)		Margin (dB)	
	(MHz)	(dB)	Q.P.	AV.	Q.P.	AV.	Q.P.	AV.	Q.P.	AV.
1	0.43121	9.90	36.20	27.77	46.10	37.67	79.00	66.00	-32.90	-28.33
2	0.46668	9.90	35.31	26.89	45.21	36.79	79.00	66.00	-33.79	-29.21
3	0.68377	9.92	25.00	17.26	34.92	27.18	73.00	60.00	-38.08	-32.82
4	0.82844	9.93	24.31	16.77	34.24	26.70	73.00	60.00	-38.76	-33.30
5	1.29720	9.95	25.25	16.28	35.20	26.23	73.00	60.00	-37.80	-33.77
6	14.11812	10.35	27.78	12.35	38.13	22.70	73.00	60.00	-34.87	-37.30

- 1. Q.P. and AV. are abbreviations of quasi-peak and average individually.
- 2. The emission levels of other frequencies were very low against the limit.
- 3. Margin value = Emission level Limit value
- 4. Correction factor = Insertion loss + Cable loss
- 5. Emission Level = Correction Factor + Reading Value

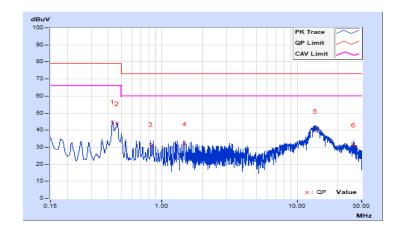




Frequency Range	1150kHz ~ 30MHz	Detector Function & Resolution Bandwidth	Quasi-Peak (QP) / Average (AV), 9kHz
Input Power	1110Vac 60Hz	Environmental Conditions	21 °C, 76 % RH
Tested by	Adam Chen		

	Phase Of Power : Neutral (N)									
No	Frequency	Correction Factor		Reading Value Emission Level (dBuV)		Limit (dBuV)		Margin (dB)		
	(MHz)	(dB)	Q.P.	AV.	Q.P.	AV.	Q.P.	AV.	Q.P.	AV.
1	0.43121	9.91	34.88	26.14	44.79	36.05	79.00	66.00	-34.21	-29.95
2	0.46668	9.92	34.00	25.38	43.92	35.30	79.00	66.00	-35.08	-30.70
3	0.82844	9.95	21.79	14.45	31.74	24.40	73.00	60.00	-41.26	-35.60
4	1.47753	9.97	22.04	12.95	32.01	22.92	73.00	60.00	-40.99	-37.08
5	13.64892	10.35	29.16	13.31	39.51	23.66	73.00	60.00	-33.49	-36.34
6	25.95486	10.56	20.70	18.85	31.26	29.41	73.00	60.00	-41.74	-30.59

- 1. Q.P. and AV. are abbreviations of quasi-peak and average individually.
- 2. The emission levels of other frequencies were very low against the limit.
- 3. Margin value = Emission level Limit value
- 4. Correction factor = Insertion loss + Cable loss
- 5. Emission Level = Correction Factor + Reading Value

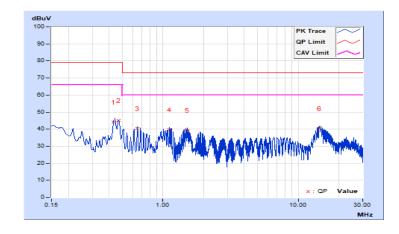




Frequency Range	150kHz ~ 30MHz	Detector Function & Resolution Bandwidth	Quasi-Peak (QP) / Average (AV), 9kHz
Input Power	230Vac, 50Hz	Environmental Conditions	21 °C, 76 % RH
Tested by	Adam Chen		

	Phase Of Power : Line (L)									
No	Frequency	Correction Factor		ng Value Emission Level BuV) (dBuV)		Limit (dBuV)		Margin (dB)		
	(MHz)	(dB)	Q.P.	AV.	Q.P.	AV.	Q.P.	AV.	Q.P.	AV.
1	0.43323	9.90	34.13	25.16	44.03	35.06	79.00	66.00	-34.97	-30.94
2	0.46856	9.90	35.32	26.16	45.22	36.06	79.00	66.00	-33.78	-29.94
3	0.64858	9.92	30.58	21.83	40.50	31.75	73.00	60.00	-32.50	-28.25
4	1.11772	9.94	29.71	20.49	39.65	30.43	73.00	60.00	-33.35	-29.57
5	1.51269	9.96	29.47	20.31	39.43	30.27	73.00	60.00	-33.57	-29.73
6	14.30184	10.36	30.00	19.52	40.36	29.88	73.00	60.00	-32.64	-30.12

- 1. Q.P. and AV. are abbreviations of quasi-peak and average individually.
- 2. The emission levels of other frequencies were very low against the limit.
- 3. Margin value = Emission level Limit value
- 4. Correction factor = Insertion loss + Cable loss
- 5. Emission Level = Correction Factor + Reading Value

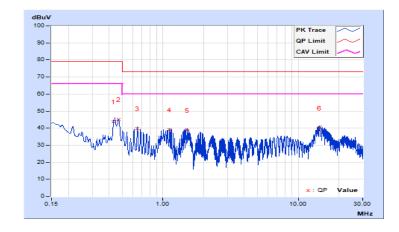




Frequency Range	150kHz ~ 30MHz	Detector Function & Resolution Bandwidth	Quasi-Peak (QP) / Average (AV), 9kHz		
Input Power	230Vac, 50Hz	Environmental Conditions	21 °C, 76 % RH		
Tested by	Adam Chen				

	Phase Of Power : Neutral (N)									
No	Frequency	Correction Factor		Reading Value Emission Level (dBuV)		Limit (dBuV)		Margin (dB)		
	(MHz)	(dB)	Q.P.	AV.	Q.P.	AV.	Q.P.	AV.	Q.P.	AV.
1	0.43310	9.91	34.00	24.75	43.91	34.66	79.00	66.00	-35.09	-31.34
2	0.46874	9.92	35.06	25.83	44.98	35.75	79.00	66.00	-34.02	-30.25
3	0.64856	9.93	29.83	21.05	39.76	30.98	73.00	60.00	-33.24	-29.02
4	1.11771	9.96	28.97	19.75	38.93	29.71	73.00	60.00	-34.07	-30.29
5	1.51269	9.98	28.84	19.63	38.82	29.61	73.00	60.00	-34.18	-30.39
6	14.33708	10.38	29.58	19.13	39.96	29.51	73.00	60.00	-33.04	-30.49

- 1. Q.P. and AV. are abbreviations of quasi-peak and average individually.
- 2. The emission levels of other frequencies were very low against the limit.
- 3. Margin value = Emission level Limit value
- 4. Correction factor = Insertion loss + Cable loss
- 5. Emission Level = Correction Factor + Reading Value





7.2 Conducted Emissions from Wired Network Ports

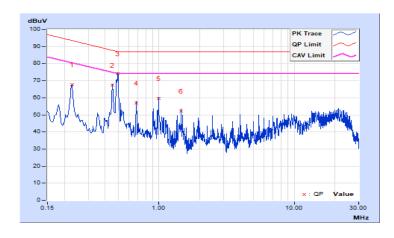
Mode 1 - RJ45 TELECOM PORT (1Gbps, TFGEN+PING)

Fraguency Banga	150kHz ~ 30MHz	Detector Function &	Quasi-Peak (QP) / Average (AV),
Frequency Range	TOURNZ ~ SUIVINZ	Resolution Bandwidth	9kHz
Innut Bower	220\/oo_F0Uz	Environmental	21 °C, 76 % RH
Input Power	230Vac, 50Hz	Conditions	21 C, 76 % KH
Tested by	Adam Chen		

No	Frequency	Correction Factor		g Value uV)	Emission Level (dBuV)		Limit (dBuV)		Margin (dB)	
	(MHz)	(dB)	Q.P.	AV.	Q.P.	AV.	Q.P.	AV.	Q.P.	AV.
1	0.22791	9.91	57.70	57.69	67.61	67.60	93.53	80.53	-25.92	-12.93
2	0.45498	9.90	57.44	57.36	67.34	67.26	87.78	74.78	-20.44	-7.52
3	0.49799	9.90	64.20	63.93	74.10	73.83	87.03	74.03	-12.93	-0.20
4	0.67986	9.89	46.88	46.59	56.77	56.48	87.00	74.00	-30.23	-17.52
5	0.99657	9.88	49.87	49.67	59.75	59.55	87.00	74.00	-27.25	-14.45
6	1.45795	9.89	42.34	41.87	52.23	51.76	87.00	74.00	-34.77	-22.24

Remarks:

- 1. Q.P. and AV. are abbreviations of quasi-peak and average individually.
- 2. The emission levels of other frequencies were very low against the limit.
- 3. Margin value = Emission level Limit value
- 4. Correction factor = Insertion loss + Cable loss
- 5. Emission Level = Correction Factor + Reading Value



Report No.: CEBDBO-WTW-P21115053 Page No. 52 / 77 Report Format Version: 7.1.0



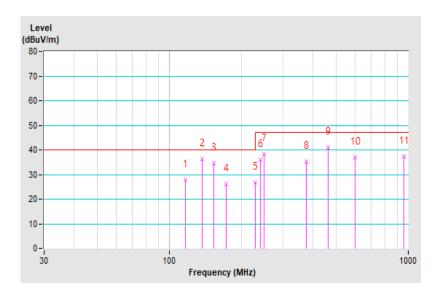
7.3 Radiated Emissions up to 1 GHz

Mode 1

Frequency Range	130MH7 ~ 1GH7	Detector Function & Resolution Bandwidth	Quasi-Peak (QP), 120kHz
Tested By	I Adam (Chen	Environmental Conditions	20 °C, 77 % RH

		Antenn	a Polarity & T	Test Distanc	e : Horizonta	l at 10 m		
No	Frequency (MHz)	Emission Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Antenna Height (m)	Table Angle (Degree)	Raw Value (dBuV)	Correction Factor (dB/m)
1	116.62	27.77 QP	40.00	-12.23	4.00 H	161	39.46	-11.69
2	137.57	36.21 QP	40.00	-3.79	4.00 H	229	45.88	-9.67
3	154.24	34.60 QP	40.00	-5.40	4.00 H	40	43.51	-8.91
4	173.48	26.21 QP	40.00	-13.79	4.00 H	330	35.82	-9.61
5	229.19	26.64 QP	40.00	-13.36	4.00 H	154	37.78	-11.14
6	240.03	35.90 QP	47.00	-11.10	3.33 H	186	45.64	-9.74
7	250.01	38.38 QP	47.00	-8.62	2.98 H	165	47.69	-9.31
8	375.01	35.19 QP	47.00	-11.81	2.16 H	231	40.45	-5.26
9	462.68	40.89 QP	47.00	-6.11	1.76 H	245	43.90	-3.01
10	600.54	37.06 QP	47.00	-9.94	1.22 H	143	36.56	0.50
11	960.00	37.25 QP	47.00	-9.75	1.00 H	252	29.17	8.08

- 1. Emission Level(dBuV/m) = Raw Value(dBuV) + Correction Factor(dB/m)
- 2. Correction Factor(dB/m) = Antenna Factor (dB/m) + Cable Factor (dB)
 - Pre-Amplifier Factor (dB)
- 3. The other emission levels were very low against the limit.
- 4. Margin value = Emission level Limit value

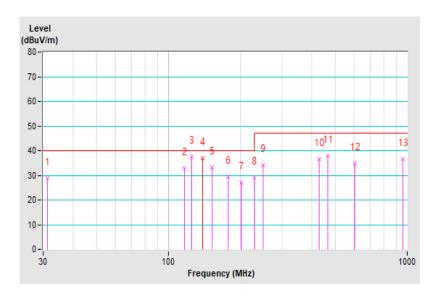




Frequency Range	130MHz ~ 1(4Hz	Detector Function & Resolution Bandwidth	Quasi-Peak (QP), 120kHz
Tested By	I Adam Chen	Environmental Conditions	20 °C, 77 % RH

		Anten	na Polarity &	Test Distan	ce : Vertical	at 10 m		
No	Frequency (MHz)	Emission Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Antenna Height (m)	Table Angle (Degree)	Raw Value (dBuV)	Correction Factor (dB/m)
1	31.39	28.73 QP	40.00	-11.27	1.00 V	134	40.56	-11.83
2	116.97	32.81 QP	40.00	-7.19	1.00 V	154	44.44	-11.63
3	125.03	37.74 QP	40.00	-2.26	1.00 V	263	48.60	-10.86
4	139.42	36.84 QP	40.00	-3.16	1.00 V	160	46.37	-9.53
5	152.81	33.31 QP	40.00	-6.69	1.00 V	109	42.31	-9.00
6	178.16	29.42 QP	40.00	-10.58	1.00 V	237	39.60	-10.18
7	202.16	27.03 QP	40.00	-12.97	1.00 V	94	39.01	-11.98
8	228.51	29.08 QP	40.00	-10.92	1.00 V	159	40.29	-11.21
9	250.00	34.40 QP	47.00	-12.60	1.00 V	134	43.71	-9.31
10	428.98	36.51 QP	47.00	-10.49	3.26 V	189	40.32	-3.81
11	464.81	37.87 QP	47.00	-9.13	2.79 V	249	40.88	-3.01
12	604.47	34.89 QP	47.00	-12.11	2.46 V	113	34.26	0.63
13	960.01	36.71 QP	47.00	-10.29	1.51 V	207	28.63	8.08

- 1. Emission Level(dBuV/m) = Raw Value(dBuV) + Correction Factor(dB/m)
- 2. Correction Factor(dB/m) = Antenna Factor (dB/m) + Cable Factor (dB)
 - Pre-Amplifier Factor (dB)
- 3. The other emission levels were very low against the limit.
- 4. Margin value = Emission level Limit value





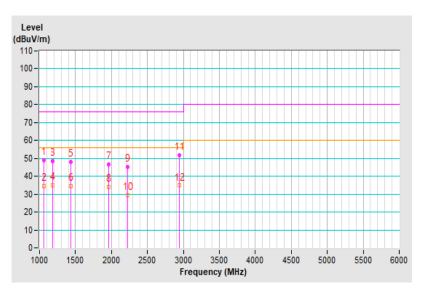
7.4 Radiated Emissions above 1 GHz

Mode 1

Frequency Range	11(3Hz ~ 6(3Hz	Detector Function & Resolution Bandwidth	Peak (PK) / Average (AV), 1MHz
Tested By	Ernie Liang	Environmental Conditions	26 °C, 78 % RH

		Antenr	na Polarity &	Test Distanc	e : Horizonta	al at 3 m		
No	Frequency (MHz)	Emission Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Antenna Height (m)	Table Angle (Degree)	Raw Value (dBuV)	Correction Factor (dB/m)
1	1065.32	48.93 PK	76.00	-27.07	1.52 H	181	52.86	-3.93
2	1065.32	34.57 AV	56.00	-21.43	1.52 H	181	38.50	-3.93
3	1179.47	48.41 PK	76.00	-27.59	1.87 H	125	52.75	-4.34
4	1179.47	35.07 AV	56.00	-20.93	1.87 H	125	39.41	-4.34
5	1436.45	48.23 PK	76.00	-27.77	1.00 H	145	52.04	-3.81
6	1436.45	34.56 AV	56.00	-21.44	1.00 H	145	38.37	-3.81
7	1962.64	46.56 PK	76.00	-29.44	1.66 H	166	48.73	-2.17
8	1962.64	33.98 AV	56.00	-22.02	1.66 H	166	36.15	-2.17
9	2220.24	45.33 PK	76.00	-30.67	1.00 H	138	46.87	-1.54
10	2220.24	29.56 AV	56.00	-26.44	1.00 H	138	31.10	-1.54
11	2944.21	51.70 PK	76.00	-24.30	1.12 H	129	50.61	1.09
12	2944.21	34.85 AV	56.00	-21.15	1.12 H	129	33.76	1.09

- 1. Emission Level(dBuV/m) = Raw Value(dBuV) + Correction Factor(dB/m)
- 2. Correction Factor(dB/m) = Antenna Factor (dB/m) + Cable Factor (dB)
 - Pre-Amplifier Factor (dB)
- 3. The other emission levels were very low against the limit.
- 4. Margin value = Emission level Limit value

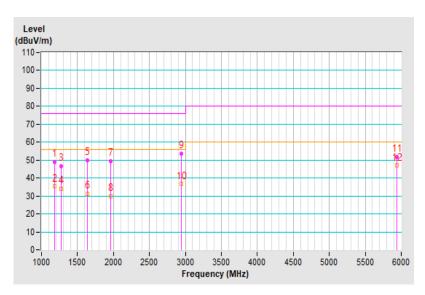




Frequency Range	11(4H2 ~ 6(4H2	Detector Function & Resolution Bandwidth	Peak (PK) / Average (AV), 1MHz
Tested By	l Ernie Liano	Environmental Conditions	26 °C, 78 % RH

		Anter	nna Polarity 8	& Test Distar	nce : Vertical	at 3 m		
No	Frequency (MHz)	Emission Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Antenna Height (m)	Table Angle (Degree)	Raw Value (dBuV)	Correction Factor (dB/m)
1	1184.35	49.12 PK	76.00	-26.88	1.12 V	204	53.53	-4.41
2	1184.35	35.26 AV	56.00	-20.74	1.12 V	204	39.67	-4.41
3	1274.08	46.72 PK	76.00	-29.28	1.65 V	190	51.00	-4.28
4	1274.08	33.98 AV	56.00	-22.02	1.65 V	190	38.26	-4.28
5	1638.51	49.78 PK	76.00	-26.22	1.58 V	234	52.83	-3.05
6	1638.51	31.13 AV	56.00	-24.87	1.58 V	234	34.18	-3.05
7	1962.03	49.63 PK	76.00	-26.37	2.01 V	204	51.78	-2.15
8	1962.03	29.81 AV	56.00	-26.19	2.01 V	204	31.96	-2.15
9	2946.65	53.65 PK	76.00	-22.35	1.69 V	175	52.27	1.38
10	2946.65	36.63 AV	56.00	-19.37	1.69 V	175	35.25	1.38
11	5940.18	51.83 PK	80.00	-28.17	1.44 V	343	45.07	6.76
12	5940.18	46.94 AV	60.00	-13.06	1.44 V	343	40.18	6.76

- 1. Emission Level(dBuV/m) = Raw Value(dBuV) + Correction Factor(dB/m)
- 2. Correction Factor(dB/m) = Antenna Factor (dB/m) + Cable Factor (dB)
 - Pre-Amplifier Factor (dB)
- 3. The other emission levels were very low against the limit.
- 4. Margin value = Emission level Limit value





7.5 Harmonic Current Measurement

Mode 1

Test Duration	5 min	Fundamental Voltage / Ampere	230.58 Vrms / 0.113 Arms
Power Consumption	6.6 W	Power Frequency	50 Hz
Power Factor	0.312	Environmental Conditions	20 °C, 72% RH
Tested By	Xun Lee		

Notes:

- 1. Limits are not specified for equipment with a rated power of 75W or less (other than lighting equipment).
- 2. According to EN 61000-3-2 the manufacturer shall specify the power of the apparatus. This value shall be used for establishing limits. The specified power shall be within +/-10% of the measured power.

7.6 Voltage Fluctuations and Flicker Measurement

Mode 1

Observation (Tp)	10 min			
Input Power	230Vac,50Hz	Environmental Conditions	20 °C, 72% RH	
Tested By	Xun Lee			

Test Parameter	Measurement Value	Limit	Remarks
P _{st}	0.319	1.00	Pass
P _{lt}	0.139	0.65	Pass
T _{max} (ms)	0.000	500	Pass
d _{max} (%)	0.000	4.00	Pass
d _c (%)	0.000	3.30	Pass

Notes:

- 1. Pst means short-term flicker indicator.
- 2. P_{lt} means long-term flicker indicator.
- 3. T_{max} means accumulated time value of d(t) with a deviation exceeding 3.3 %.
- 4. d_{max} means maximum relative voltage change.
- 5. d_c means maximum relative steady-state voltage change.

Report No.: CEBDBO-WTW-P21115053 Page No. 57 / 77 Report Format Version: 7.1.0



7.7 Electrostatic Discharge (ESD)

Mode 1

Input Power	230Vac, 50 Hz	Tested by	Sean Chou
Environmental Conditions	22°C, 42% RH, 1009 mbar		

Test Results of Direct Application						
Discharge Level (kV)	Polarity (+/-)	Test Point	Contact Discharge	Air Discharge	Performance Criteria	
2, 4	+/-	1, 2	Note	NA	Α	
2, 4, 8	+/-	3-12	NA	Note	Α	

Description of test points of direct application: Please refer to following page for representative mark only.

Test Results of Indirect Application						
Discharge Level (kV)	Polarity (+/-)	Test Point	Horizontal Coupling Plane	Vertical Coupling Plane	Performance Criteria	
2, 4	+/-	Four Sides	Note	Note	A	

Description of test points of indirect application:

1. Front side

2. Rear side

3. Right side

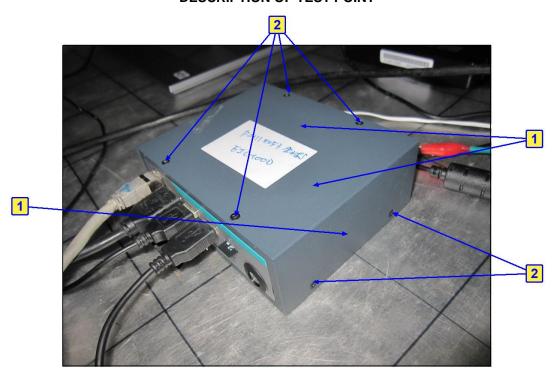
4. Left side

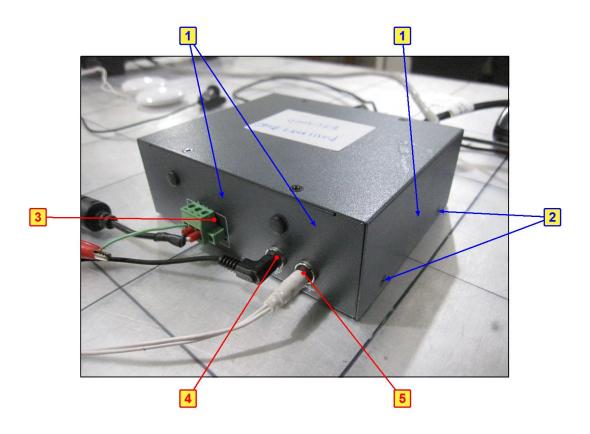
Note: The EUT is operated normal during the test.

Report No.: CEBDBO-WTW-P21115053 Page No. 58 / 77 Report Format Version: 7.1.0

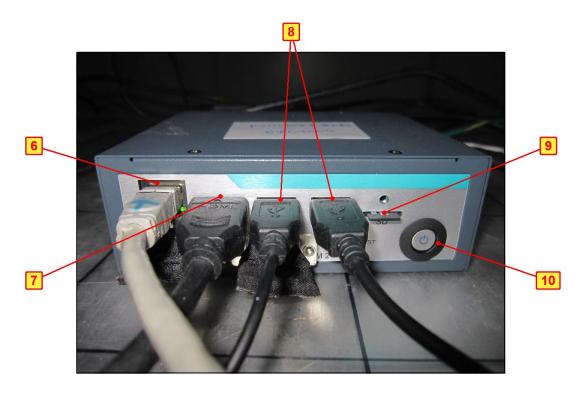


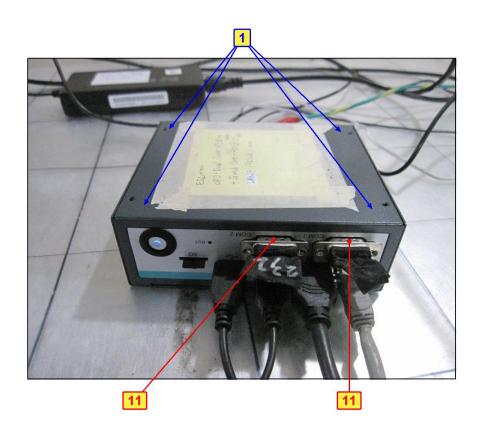
DESCRIPTION OF TEST POINT

















7.8 Radio Frequency Electromagnetic Field (RS)

Mode 1

Input Power	230Vac, 50 Hz	Tested by	Sean Chou
Environmental Conditions	23°C, 70% RH		

		Applied Field Streng		lied Field Strength		Performance
Frequency (MHz)	Polarity	Azimuth(°)	Azimuth(°) (V/m) Mode		Observation	Criteria
80 - 1000	V&H	0, 90, 180, 270	3	80% AM (1kHz)	Note 1	Α
1800, 2600, 3500, 5000 MHz	V&H	0, 90, 180, 270	3	80% AM (1kHz)	Note 1	А
80 - 1000	V&H	0, 90, 180, 270	3	80% AM (1kHz)	Note 2	Α
1800, 2600, 3500, 5000 MHz	V&H	0, 90, 180, 270	3	80% AM (1kHz)	Note 2	А

Note: 1. The EUT is operated normal during the test.

2. Audio output function (audio out) acoustic reference level is Pass.

7.9 Fast Transients Common Mode (EFT)

Mode 1

Input Power	230Vac, 50 Hz	Tested by	Xun Lee
Environmental Conditions	25°C, 70% RH		

Input AC power port

Voltage (kV)	Test Point	Polarity (+/-)	Observation	Performance Criteria
1	L	+/-	Note	Α
1	N	+/-	Note	A
1	PE	+/-	Note	Α
1	L-N-PE	+/-	Note	Α

Wired network and signal/ control port

Volta	ge (kV)	Test Point	Polarity (+/-)	Observation	Performance Criteria
() 5	LAN	+/-	Note	A

Note: The EUT is operated normal during the test.

Report No.: CEBDBO-WTW-P21115053 Page No. 62 / 77 Report Format Version: 7.1.0



7.10 Surge

Mode 1

Input Power	230Vac, 50 Hz	Tested by	Bernie Lu
Environmental Conditions	20°C, 66% RH		

Input AC power port

Voltage (kV)	Test Point	Azimuth(°)	Polarity (+/-)	Observation	Performance Criteria
0.5, 1	L-N	90, 270	+/-	Note	Α
0.5, 1, 2	L-PE	90, 270	+/-	Note	Α
0.5, 1, 2	N-PE	90, 270	+/-	Note	A

Note: The EUT is operated normal during the test.

7.11 Radio Frequency Common Mode (CS)

Mode 1

Input Power	230Vac, 50 Hz	Tested by	Todd Chang
Environmental Conditions	21°C, 66% RH		

Frequency (MHz)	Level (Vrms)	Tested Line	Injection Method	Return Path	Observation	Performance Criteria
0.15 – 10	3	AC Power	CDN-M3	CDN-M1	Note 1	Α
10 – 30	3 – 1	AC Power	CDN-M3	CDN-M1	Note 1	Α
30 – 80	1	AC Power	CDN-M3	CDN-M1	Note 1	Α
0.15 – 10	3	AC Power	CDN-M3	CDN-M1	Note 2	Α
10 – 30	3 – 1	AC Power	CDN-M3	CDN-M1	Note 2	Α
30 – 80	1	AC Power	CDN-M3	CDN-M1	Note 2	Α
0.15 – 10	3	LAN	CDN-ST08A	CDN-M1	Note 1	Α
10 – 30	3 – 1	LAN	CDN-ST08A	CDN-M1	Note 1	Α
30 – 80	1	LAN	CDN-ST08A	CDN-M1	Note 1	Α
0.15 – 10	3	LAN	CDN-ST08A	CDN-M1	Note 2	Α
10 – 30	3 – 1	LAN	CDN-ST08A	CDN-M1	Note 2	Α
30 – 80	1	LAN	CDN-ST08A	CDN-M1	Note 2	А

Note: 1. The EUT is operated normal during the test.

2. Audio output function (audio out) acoustic reference level is Pass.

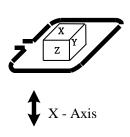
Report No.: CEBDBO-WTW-P21115053 Page No. 63 / 77 Report Format Version: 7.1.0

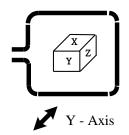


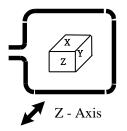
7.12 Power Frequency Magnetic Field (PFMF)

Mode 1

Input Power	230Vac, 50 Hz	Tested by	Xun Lee
Environmental Conditions	20°C, 82% RH		







Application	Frequency (Hz)	Field Strength (A/m)	Observation	Performance Criteria
X - Axis	50	1	Note	A
Y - Axis	50	1	Note	A
Z - Axis	50	1	Note	A

Note: The EUT is operated normal during the test.



7.13 **Voltage Dips and Interruptions (DIP)**

Mode 1

Wode			
	230Vac, 50 Hz;		
Input Power	240Vac, 50 Hz;	Tested by	Xun Lee
	100Vac, 50 Hz		
Environmental Conditions	20°C, 75% RH		

Input Power for testing: 230Vac, 50 Hz (Nominal input Voltage)							
Voltage Residual (%) Duration (cycle) Interval (sec) Times Observation Performant							
< 5	0.5	10	3	Note 1	А		
70	25	10	3	Note 1	Α		
< 5	250	10	3	Note 2	С		

Input Power for testing: 240Vac, 50 Hz (Maximum rated input voltage)							
Voltage Residual (%) Duration (cycle) Interval (sec) Times Observation							
< 5	0.5	10	3	Note 1	Α		
70	25	10	3	Note 1	А		
< 5	250	10	3	Note 2	С		

	Input Power for testing: 100Vac, 50 Hz (Minimum rated input voltage)						
Voltage Residual (%) Duration (cycle) Interval (sec) Times Observation Perfo							
< 5	0.5	10	3	Note 1	А		
70	25	10	3	Note 2	С		
< 5	250	10	3	Note 2	С		

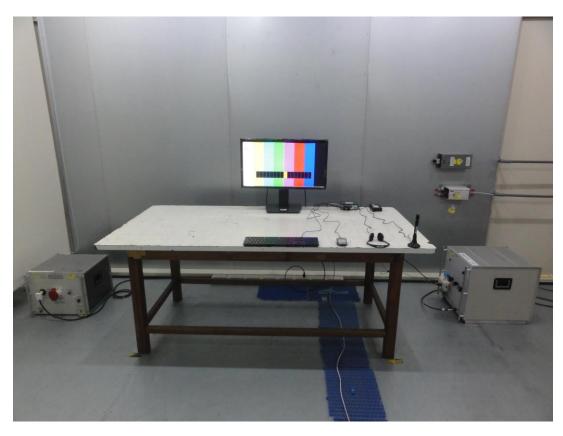
Note: 1. The EUT is operated normal during the test.
2. The EUT shutdown during the test, and need manual recoverable after the test.

Report No.: CEBDBO-WTW-P21115053 Page No. 65 / 77 Report Format Version: 7.1.0



8 Pictures of Test Arrangements

8.1 Conducted Emissions from Power Ports







8.2 Conducted Emissions from Wired Network Ports







8.3 Radiated Emissions up to 1 GHz







8.4 Radiated Emissions above 1 GHz







8.5 Harmonic Current Measurement



8.6 Voltage Fluctuations and Flicker Measurement



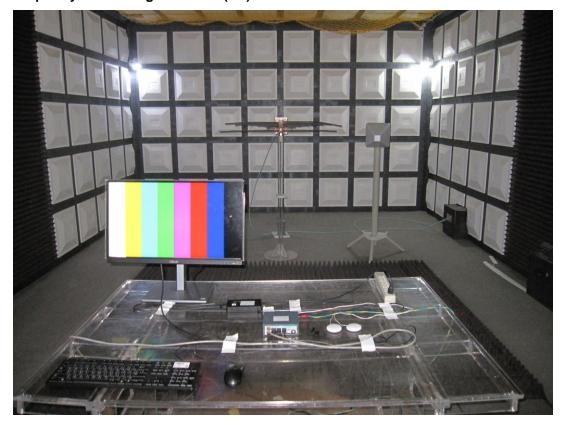


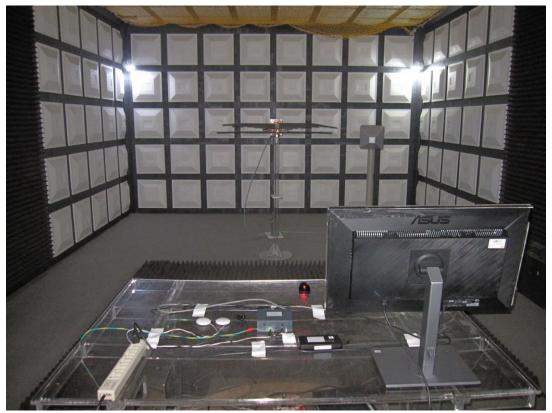
8.7 Electrostatic Discharge (ESD)





8.8 Radio Frequency Electromagnetic Field (RS)

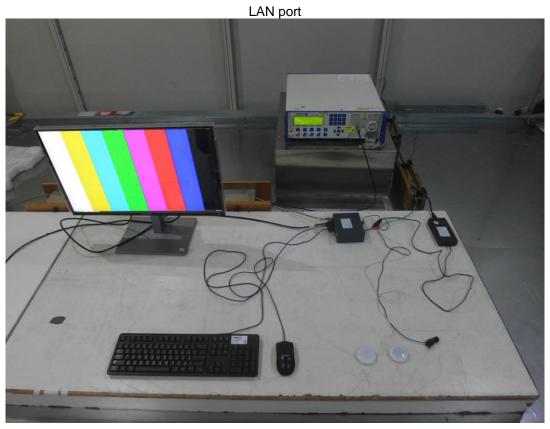






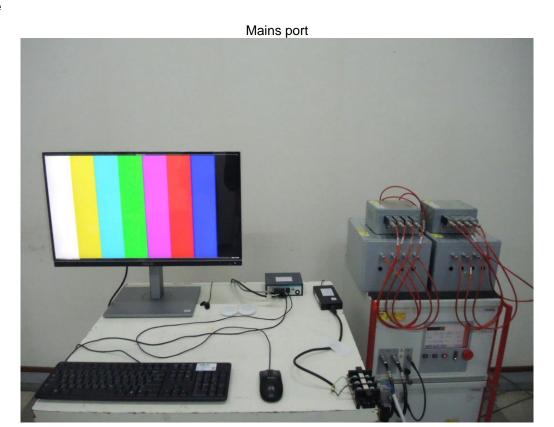
8.9 Fast Transients Common Mode (EFT)





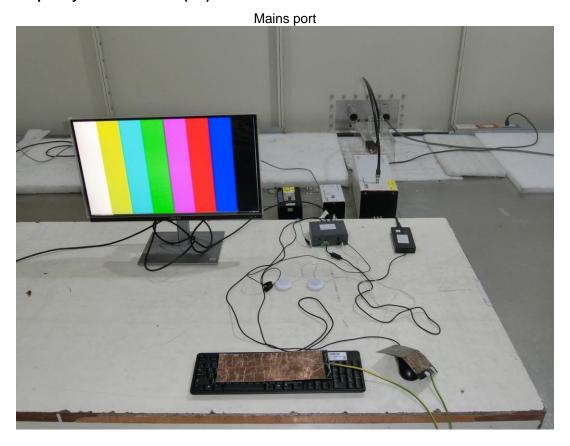


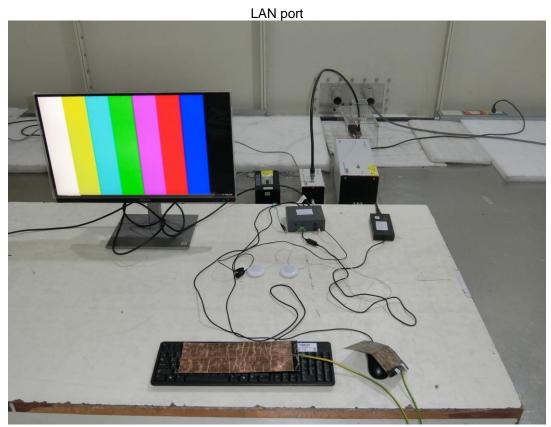
8.10 Surge





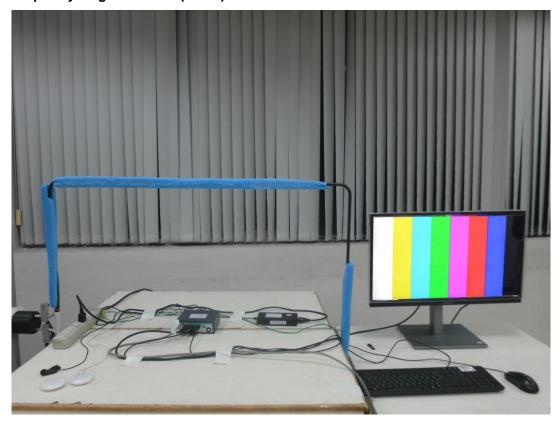
8.11 Radio Frequency Common Mode (CS)



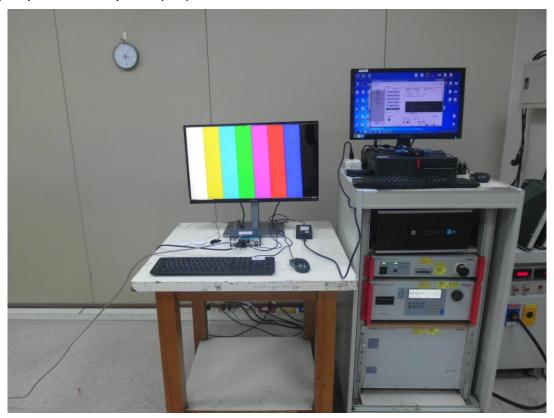




8.12 Power-frequency magnetic fields (PFMF)



8.13 Voltage Dips and Interruptions (DIP)





9 Information of the Testing Laboratories

We, Bureau Veritas Consumer Products Services (H.K.) Ltd., Taoyuan Branch, were founded in 1988 to provide our best service in EMC, Radio, Telecom and Safety consultation. Our laboratories are accredited and approved according to ISO/IEC 17025.

Hsin Chu EMC/RF/Telecom Lab

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The address and road map of all our labs can be found in our web site also.

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Report No.: CEBDBO-WTW-P21115053 Page No. 77 / 77 Report Format Version: 7.1.0